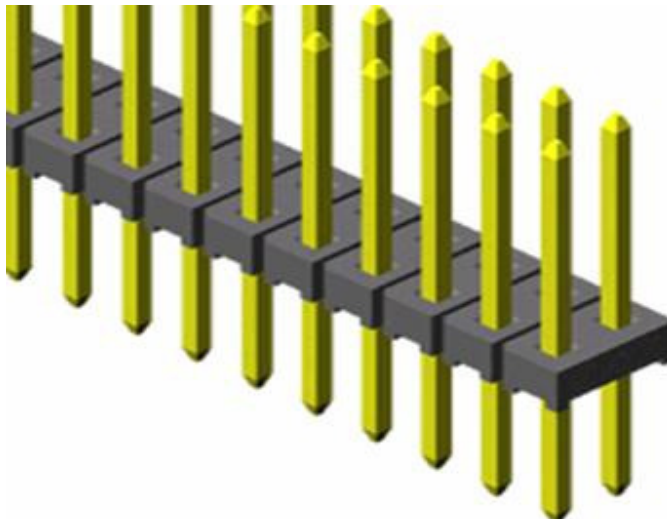
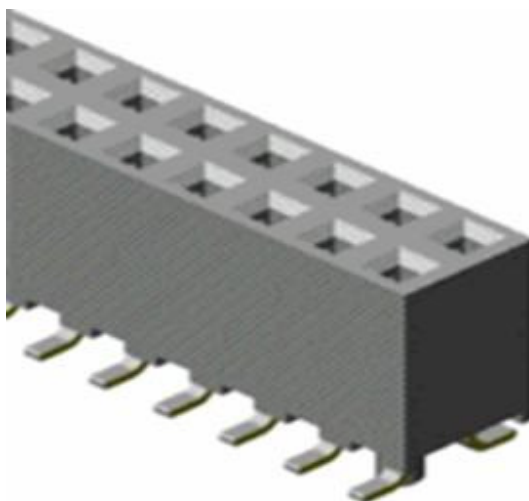




Project Number: Design Qualification Test Report		Tracking Code: 114326_Report_Rev_1	
Requested by: Mark Shireman		Date: 12/20/2011	Product Rev: N/A
Part #: SQW-125-01-S-D-VS-A/TMM-125-01-S-D-SM		Lot #: N/A	Tech: Peter Chen Eng: Vico Zhao
Part description: SQW/TMM			Qty to test: 80
Test Start: 3/23/2011	Test Completed: 4/21/2011		



DESIGN QUALIFICATION TEST REPORT

SQW/TMM

SQW-125-01-S-D-VS-A/TMM-125-01-S-D-SM

Tracking Code: 114326_Report_Rev_1	Part #: SQW-125-01-S-D-VS-A/TMM-125-01-S-D-SM
Part description: SQW/TMM	

CERTIFICATION

All instruments and measuring equipment were calibrated to National Institute for Standards and Technology (NIST) traceable standards according to ISO 10012-1 and ANSI/NCSL 2540-1, as applicable.

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SCOPE

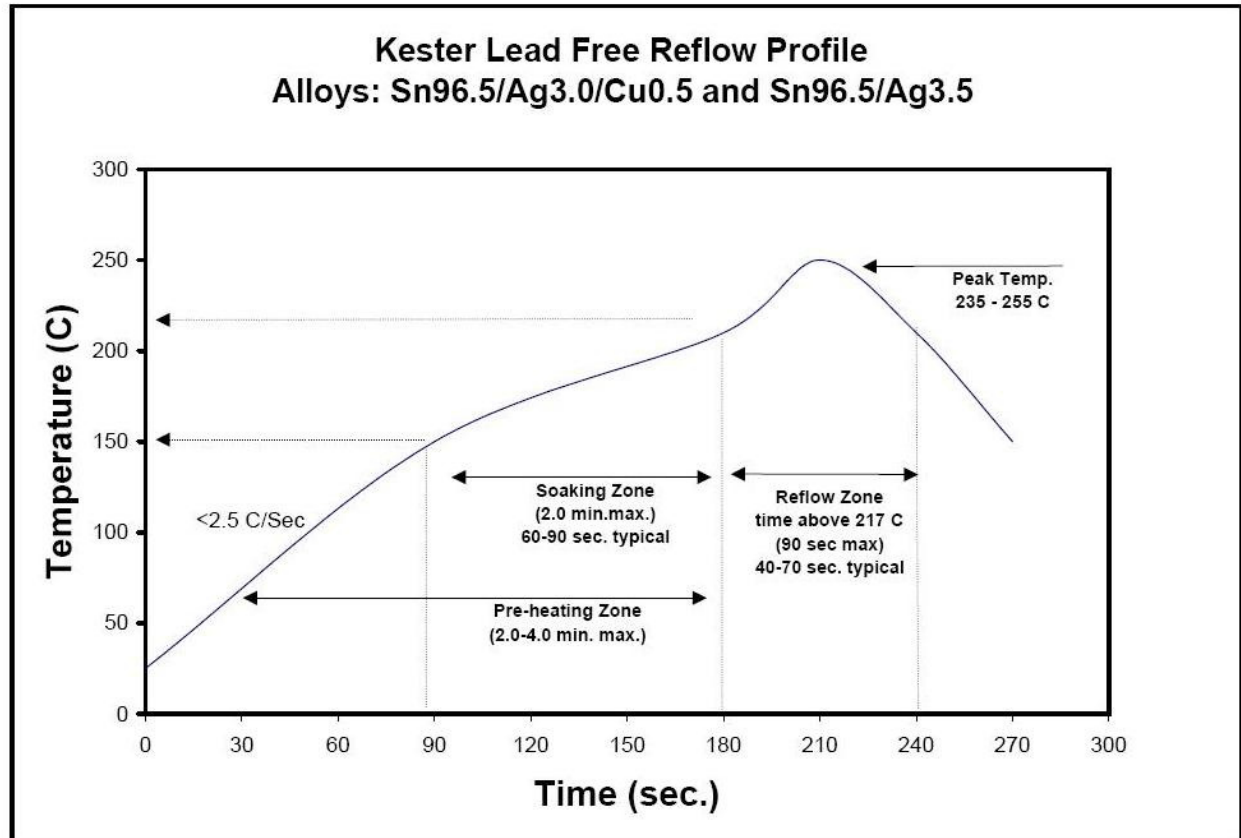
To perform the following tests: Design qualification test. Please see test plan.

APPLICABLE DOCUMENTS

Standards: EIA Publication 364

TEST SAMPLES AND PREPARATION

- 1) All materials were manufactured in accordance with the applicable product specification.
- 2) All test samples were identified and encoded to maintain traceability throughout the test sequences.
- 3) After soldering, the parts to be used for LLCR and DWV/IR testing were cleaned according to TLWI-0001.
- 4) Either an automated cleaning procedure or an ultrasonic cleaning procedure may be used.
- 5) The automated procedure is used with aqueous compatible soldering materials.
- 6) Parts not intended for testing LLCR and DWV/IR are visually inspected and cleaned if necessary.
- 7) Any additional preparation will be noted in the individual test sequences.
- 8) Solder Information: Lead Free
- 9) Re-Flow Time/Temp: See accompanying profile.
- 10) Samtec Test PCBs used:

TYPICAL OVEN PROFILE (Soldering Parts to Test Boards)

FLOWCHARTS**Gas Tight**

TEST STEP	GROUP A1 192 Points
01	LLCR-1
02	Gas Tight
03	LLCR-2

Gas Tight = EIA-364-36A

LLCR = EIA-364-23, LLCR

20 mV Max, 100 mA Max

Use Keithley 580 or 3706 in 4 wire dry circuit mode

Normal Force

TEST STEP	GROUP A1 Individual Contacts (8-10 min)	GROUP A2 Individual Contacts (8-10 min)
01	Contact Gaps	Contact Gaps
02	Setup Approved	Thermal Aging (Mated and Undisturbed)
03	Normal Force (in the body and soldered on PCB unless otherwise specified)	Contact Gaps
04		Setup Approved
05		Normal Force (in the body and soldered on PCB unless otherwise specified)

Thermal Aging = EIA-364-17, Test Condition 4 (105°C)

Time Condition 'B' (250 Hours)

Normal Force = EIA-364-04

(Perpendicular) Displacement Force = 12.7 mm/min $\pm$ 6 mm/min

Spec is 50 N @ 1 mm displacement

Contact Gaps / Height - No standard method. Usually measured optically

Gaps to be taken on a minimum of 20% of each part tested

FLOWCHARTS Continued**Thermal Aging**

TEST STEP	GROUP A1 8 Boards Thermal Aging (Mated)
01	Contact Gaps
02	Forces - Mating / Unmating
03	LLCR-1
04	Thermal Aging (Mated and Undisturbed)
05	LLCR-2
06	Forces - Mating / Unmating
07	Contact Gaps

Thermal Aging = EIA-364-17, Test Condition 4 (105°C)

Time Condition 'B' (250 Hours)

Mating / Unmating Forces = EIA-364-13

Contact Gaps / Height - No standard method. Usually measured optically.

Gaps to be taken on a minimum of 20% of each part tested

LLCR = EIA-364-23, LLCR

20 mV Max, 100 mA Max

Use Keithley 580 or 3706 in 4 wire dry circuit mode

FLOWCHARTS Continued**Durability/Mating/Unmating/Gaps**

TEST STEP	GROUP B1 8 Boards (middle position submitted)	GROUP B2 8 Boards (largest position submitted)	GROUP B3 8 Boards (smallest position submitted)
01	Contact Gaps	Contact Gaps	Contact Gaps
02	LLCR-1	Forces - Mating / Unmating	Forces - Mating / Unmating
03	Forces - Mating / Unmating	25 Cycles	25 Cycles
04	25 Cycles	Forces - Mating / Unmating	Forces - Mating / Unmating
05	Forces - Mating / Unmating	25 Cycles (50 Total)	25 Cycles (50 Total)
06	25 Cycles (50 Total)	Forces - Mating / Unmating	Forces - Mating / Unmating
07	Forces - Mating / Unmating	25 Cycles (75 Total)	25 Cycles (75 Total)
08	25 Cycles (75 Total)	Forces - Mating / Unmating	Forces - Mating / Unmating
09	Forces - Mating / Unmating	25 Cycles (100 Total)	25 Cycles (100 Total)
10	25 Cycles (100 Total)	Forces - Mating / Unmating	Forces - Mating / Unmating
11	Forces - Mating / Unmating		
12	Clean w/Compressed Air		
13	Contact Gaps		
14	LLCR-2		
15	Thermal Shock (Mated and Undisturbed)		
16	LLCR-3		
17	Cyclic Humidity (Mated and Undisturbed)		
18	LLCR-4		
19	Forces - Mating / Unmating		

Thermal Shock = EIA-364-32, Table II, Test Condition I:

-55°C to +85°C 1/2 hour dwell, 100 cycles

Humidity = EIA-364-31, Test Condition B (240 Hours)

and Method III (+25°C to +65°C @ 90% RH to 98% RH)

ambient pre-condition and delete steps 7a and 7b

Mating / Unmating Forces = EIA-364-13

Contact Gaps / Height - No standard method. Usually measured optically.

Gaps to be taken on a minimum of 20% of each part tested

LLCR = EIA-364-23, LLCR

20 mV Max, 100 mA Max

Use Keithley 580 or 3706 in 4 wire dry circuit mode

FLOWCHARTS Continued**IR & DWV**

TEST STEP	GROUP A1 2 Mated Sets Break Down Pin-to-Pin	GROUP A2 2 Unmated of Part # Being Tested Break Down Pin-to-Pin	GROUP A3 2 Unmated of Mating Part # Break Down Pin-to-Pin	GROUP B1 2 Mated Sets Pin-to-Pin
01	DWV/Break Down Voltage	DWV/Break Down Voltage	DWV/Break Down Voltage	IR & DWV at test voltage (on both mated sets and on each connector unmated)
02				Thermal Shock (Mated and Undisturbed)
03				IR & DWV at test voltage (on both mated sets and on each connector unmated)
04				Cyclic Humidity (Mated and Undisturbed)
05				IR & DWV at test voltage (on both mated sets and on each connector unmated)

DWV on Group B1 to be performed at Test Voltage

DWV test voltage is equal to 75% of the lowest break down voltage from Groups A1, A2 or A3

Thermal Shock = EIA-364-32, Table II, Test Condition I:

-55°C to +85°C 1/2 hour dwell, 100 cycles

Humidity = EIA-364-31, Test Condition B (240 Hours)

and Method III (+25°C to +65°C @ 90% RH to 98% RH)

ambient pre-condition and delete steps 7a and 7b

IR = EIA-364-21

DWV = EIA-364-20, Test Condition 1

FLOWCHARTS Continued**Current Carrying Capacity - Double Row**

TEST STEP	GROUP B1 3 Mated Assemblies 2 Contacts Powered	GROUP B2 3 Mated Assemblies 4 Contacts Powered	GROUP B3 3 Mated Assemblies 6 Contacts Powered	GROUP B4 3 Mated Assemblies 8 Contacts Powered	GROUP B5 3 Mated Assemblies All Contacts Powered
01	CCC	CCC	CCC	CCC	CCC

(TIN PLATING) - Tabulate calculated current at RT, 65°C, 75°C and 95°C
after derating 20% and based on 105°C

(GOLD PLATING) - Tabulate calculated current at RT, 85°C, 95°C and 115°C
after derating 20% and based on 125°C

CCC, Temp rise = EIA-364-70

Mechanical Shock / Vibration / LLCR

TEST STEP	GROUP A1 192 Points
01	LLCR-1
02	Shock
03	Vibration
04	LLCR-2

Mechanical Shock = EIA 364-27 Half Sine,

100 g's, 6 milliSeconds (Condition "C") each axis

Vibration = EIA 364-28, Random Vibration

7.56 g RMS, Condition VB --- 2 hours/axis

LLCR = EIA-364-23, LLCR

20 mV Max, 100 mA Max

Use Keithley 580 or 3706 in 4 wire dry circuit mode

Shock / Vibration / nanoSecond Event Detection

TEST STEP	GROUP A1 60 Points
01	Event Detection, Shock
02	Event Detection, Vibration

Mechanical Shock = EIA 364-27 Half Sine,

100 g's, 6 milliSeconds (Condition "C") each axis

Vibration = EIA 364-28, Random Vibration

7.56 g RMS, Condition VB --- 2 hours/axis

Event detection requirement during Shock / Vibration is 50 nanoseconds minimum

ATTRIBUTE DEFINITIONS

The following is a brief, simplified description of attributes.

THERMAL SHOCK:

- 1) EIA-364-32, *Thermal Shock (Temperature Cycling) Test Procedure for Electrical Connectors*.
- 2) Test Condition 1: -55°C to +85°C
- 3) Test Time: ½ hour dwell at each temperature extreme
- 4) Number of Cycles: 100
- 5) All test samples are pre-conditioned at ambient.
- 6) All test samples are exposed to environmental stressing in the mated condition.

THERMAL:

- 1) EIA-364-17, *Temperature Life with or without Electrical Load Test Procedure for Electrical Connectors*.
- 2) Test Condition 4 at 105° C.
- 3) Test Time Condition B for 250 hours.
- 4) All test samples are pre-conditioned at ambient.
- 5) All test samples are exposed to environmental stressing in the mated condition.

HUMIDITY:

- 1) Reference document: EIA-364-31, *Humidity Test Procedure for Electrical Connectors*.
- 2) Test Condition B, 240 Hours.
- 3) Method III, +25° C to + 65° C, 90% to 98% Relative Humidity excluding sub-cycles 7a and 7b.
- 4) All samples are pre-conditioned at ambient.
- 5) All test samples are exposed to environmental stressing in the mated condition.

MECHANICAL SHOCK (Specified Pulse):

- 1) Reference document: EIA-364-27, *Mechanical Shock Test Procedure for Electrical Connectors*
- 2) Test Condition C
- 3) Peak Value: 100 G
- 4) Duration: 6 Milliseconds
- 5) Wave Form: Half Sine
- 6) Velocity: 12.3 ft/s
- 7) Number of Shocks: 3 Shocks / Direction, 3 Axis (18 Total)

VIBRATION:

- 1) Reference document: EIA-364-28, *Vibration Test Procedure for Electrical Connectors*
- 2) Test Condition V, Letter B
- 3) Power Spectral Density: 0.04 G² / Hz
- 4) G 'RMS': 7.56
- 5) Frequency: 50 to 2000 Hz
- 6) Duration: 2.0 Hours per axis (3 axis total)

NANOSECOND-EVENT DETECTION:

- 1) Reference document: EIA-364-87, *Nanosecond-Event Detection for Electrical Connectors*
- 2) Prior to test, the samples were characterized to assure the low nanosecond event being monitored will trigger the detector.
- 3) After characterization it was determined the test samples could be monitored for 50 nanosecond events

ATTRIBUTE DEFINITIONS Continued

The following is a brief, simplified description of attributes.

TEMPERATURE RISE (Current Carrying Capacity, CCC):

- 1) EIA-364-70, *Temperature Rise versus Current Test Procedure for Electrical Connectors and Sockets*.
- 2) When current passes through a contact, the temperature of the contact increases as a result of I^2R (resistive) heating.
- 3) The number of contacts being investigated plays a significant part in power dissipation and therefore temperature rise.
- 4) The size of the temperature probe can affect the measured temperature.
- 5) Copper traces on PC boards will contribute to temperature rise:
 - a. Self heating (resistive)
 - b. Reduction in heat sink capacity affecting the heated contacts
- 6) A de-rating curve, usually 20%, is calculated.
- 7) Calculated de-rated currents at three temperature points are reported:
 - a. Ambient
 - b. 80° C
 - c. 95° C
 - d. 115° C
- 8) Typically, neighboring contacts (in close proximity to maximize heat build up) are energized.
- 9) The thermocouple (or temperature measuring probe) will be positioned at a location to sense the maximum temperature in the vicinity of the heat generation area.
- 10) A computer program, *TR 803.exe*, ensures accurate stability for data acquisition.
- 11) Hook-up wire cross section is larger than the cross section of any connector leads/PC board traces, jumpers, etc.
- 12) Hook-up wire length is longer than the minimum specified in the referencing standard.

CONTACT GAPS:

- 1) Gaps above the surrounding plastic surface were measured before and after stressing the contacts (e.g. thermal aging, mechanical cycling, etc.).
- 2) Typically, all contacts on the connector are measured.

MATING/UNMATING:

- 1) Reference document: EIA-364-13, *Mating and Unmating Forces Test Procedure for Electrical Connectors*.
- 2) The full insertion position was to within 0.003" to 0.004" of the plug bottoming out in the receptacle to prevent damage to the system under test.
- 3) One of the mating parts is secured to a floating X-Y table to prevent damage during cycling.

ATTRIBUTE DEFINITIONS Continued

The following is a brief, simplified description of attributes.

NORMAL FORCE (FOR CONTACTS TESTED OUTSIDE THE HOUSING):

- 1) Reference document: EIA-364-04, *Normal Force Test Procedure for Electrical Connectors*.
- 2) The contacts shall be tested in the loose state, *not* inserted in connector housing.
- 3) The contacts shall be prepared to allow access to the spring member at the same attitude and deflection level as would occur in actual use.
- 4) In the event that portions of the contact prevent insertion of the test probe and/or deflection of the spring member under evaluation, said material shall be removed leaving the appropriate contact surfaces exposed.
- 5) In the case of multi-tine contacts, each tine shall be tested independently on separate samples as required.
- 6) The connector housing shall be simulated, if required, in order to provide an accurate representation of the actual contact system performance.
- 7) A holding fixture shall be fashioned to allow the contact to be properly deflected.
- 8) Said holding fixture shall be mounted on a floating, adjustable, X-Y table on the base of the Dillon TC², computer controlled test stand with a deflection measurement system accuracy of 5 μ m (0.0002").
- 9) The probe shall be attached to a Dillon P/N 49761-0105, 5 N (1.1 Lb) load cell providing an accuracy of $\pm$ 0.2%.
- 10) The nominal deflection rate shall be 5 mm (0.2")/minute.
- 11) Unless otherwise noted a minimum of five contacts shall be tested.
- 12) The force/deflection characteristic to load and unload each contact shall be repeated five times.
- 13) The system shall utilize the TC² software in order to acquire and record the test data.
- 14) The permanent set of each contact shall be measured within the TC² software.
- 15) The acquired data shall be graphed with the deflection data on the X-axis and the force data on the Y-axis and a print out will be stored with the Tracking Code paperwork.

ATTRIBUTE DEFINITIONS Continued

The following is a brief, simplified description of attributes.

INSULATION RESISTANCE (IR):

To determine the resistance of insulation materials to leakage of current through or on the surface of these materials when a DC potential is applied.

- 1) PROCEDURE:
 - a. Reference document: EIA-364-21, *Insulation Resistance Test Procedure for Electrical Connectors*.
 - b. Test Conditions:
 - i. Between Adjacent Contacts or Signal-to-Ground
 - ii. Electrification Time 2.0 minutes
 - iii. Test Voltage (500 VDC) corresponds to calibration settings for measuring resistances.
- 2) MEASUREMENTS:
- 3) When the specified test voltage is applied (VDC), the insulation resistance shall not be less than 5000 megohms.

DIELECTRIC WITHSTANDING VOLTAGE (DWV):

To determine if the sockets can operate at its rated voltage and withstand momentary over potentials due to switching, surges, and other similar phenomenon. Separate samples are used to evaluate the effect of environmental stresses so not to influence the readings from arcing that occurs during the measurement process.

- 1) PROCEDURE:
 - a. Reference document: EIA-364-20, *Withstanding Voltage Test Procedure for Electrical Connectors*.
 - b. Test Conditions:
 - i. Between Adjacent Contacts or Signal-to-Ground
 - ii. Barometric Test Condition 1
 - iii. Rate of Application 500 V/Sec
 - iv. Test Voltage (VAC) until breakdown occurs
- 2) MEASUREMENTS/CALCULATIONS
 - a. The breakdown voltage shall be measured and recorded.
 - b. The dielectric withstanding voltage shall be recorded as 75% of the minimum breakdown voltage.
 - c. The working voltage shall be recorded as one-third (1/3) of the dielectric withstanding voltage (one-fourth of the breakdown voltage).

LLCR:

- 1) EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets*.
- 2) A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
- 3) The following guidelines are used to categorize the changes in LLCR as a result from stressing
 - a. $\leq +5.0$ mOhms: -----Stable
 - b. $+5.1$ to $+10.0$ mOhms:-----Minor
 - c. $+10.1$ to $+15.0$ mOhms: -----Acceptable
 - d. $+15.1$ to $+50.0$ mOhms: -----Marginal
 - e. $+50.1$ to $+2000$ mOhms: -----Unstable
 - f. $>+2000$ mOhms:-----Open Failure

ATTRIBUTE DEFINITIONS Continued

The following is a brief, simplified description of attributes.

GAS TIGHT:

To provide method for evaluating the ability of the contacting surfaces in preventing penetration of harsh vapors which might lead to oxide formation that may degrade the electrical performance of the contact system.

- 1) EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets*.
- 2) A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
- 3) The following guidelines are used to categorize the changes in LLCR as a result from stressing
 - a. $\leq +5.0$ mOhms: -----Stable
 - b. $+5.1$ to $+10.0$ mOhms:-----Minor
 - c. $+10.1$ to $+15.0$ mOhms: -----Acceptable
 - d. $+15.1$ to $+50.0$ mOhms: -----Marginal
 - e. $+50.1$ to $+2000$ mOhms: -----Unstable
 - f. $>+2000$ mOhms:-----Open Failure
- 4) Procedure:
 - a. Reference document: EIA-364-36, *Test Procedure for Determination of Gas-Tight Characteristics for Electrical Connectors, Sockets and/or Contact Systems*.
 - b. Test Conditions:
 - i. Class II--- Mated pairs of contacts assembled to their plastic housings.
 - ii. Reagent grade Nitric Acid shall be used of sufficient volume to saturate the test chamber
 - iii. The ratio of the volume of the test chamber to the surface area of the acid shall be 10:1.
 - iv. The chamber shall be saturated with the vapor for at least 15 minutes before samples are added.
 - v. Exposure time, 55 to 65 minutes.
 - vi. The samples shall be no closer to the chamber walls than 1 inches and no closer to the surface of the acid than 3 inches.
 - vii. The samples shall be dried after exposure for a minimum of 1 hour.
 - viii. Drying temperature 50°C
 - ix. The final LLCR shall be conducted within 1 hour after drying.

RESULTS

Temperature Rise, CCC at a 20% de-rating

- CCC for a 30°C Temperature Rise-----4.3A per contact with 2 adjacent contacts powered
- CCC for a 30°C Temperature Rise-----2.9A per contact with 4 adjacent contacts powered
- CCC for a 30°C Temperature Rise-----2.8A per contact with 6 adjacent contacts powered
- CCC for a 30°C Temperature Rise-----2.5A per contact with 8 adjacent contacts powered
- CCC for a 30°C Temperature Rise-----1.6A per contact with all adjacent contacts powered

Contact Gaps

Normal Force Group

Group A1

- Initial
 - Min-----0.250 mm
 - Max -----0.266 mm

Group A2

- Initial
 - Min-----0.250 mm
 - Max -----0.266 mm
- Thermal
 - Min-----0.276 mm
 - Max -----0.284 mm

Thermal Aging Group

- Initial
 - Min-----0.248 mm
 - Max -----0.320 mm
- Thermal
 - Min-----0.276 mm
 - Max -----0.314 mm

Mating\Unmating Durability Group

- Initial
 - Min-----0.256 mm
 - Max -----0.284 mm
- After 100 Cycles
 - Min-----0.256 mm
 - Max -----0.294 mm

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Part description: SQW/TMM	

RESULTS Continued

Mating – Unmating Forces

Thermal Aging Group

- **Initial**
 - **Mating**
 - **Min** ----- **7.17Lbs**
 - **Max** ----- **9.39Lbs**
 - **Unmating**
 - **Min** ----- **5.07Lbs**
 - **Max** ----- **7.04Lbs**
- **Thermal**
 - **Mating**
 - **Min** ----- **5.25Lbs**
 - **Max** ----- **8.27Lbs**
 - **Unmating**
 - **Min** ----- **4.80Lbs**
 - **Max** ----- **6.39Lbs**

RESULTS Continued**Mating – Unmating Forces****Mating\Unmating Durability Group B1 (SQW-125-01-S-D-VS-A/TMM-125-01-S-D-SM)**

- **Initial**
 - **Mating**
 - **Min**-----6.54 Lbs
 - **Max**-----8.06 Lbs
 - **Unmating**
 - **Min**-----5.07 Lbs
 - **Max**-----6.06 Lbs
- **After 25 Cycles**
 - **Mating**
 - **Min**-----6.61 Lbs
 - **Max**-----8.52 Lbs
 - **Unmating**
 - **Min**-----5.81 Lbs
 - **Max**-----8.03 Lbs
- **After 50 Cycles**
 - **Mating**
 - **Min**-----6.81 Lbs
 - **Max**-----9.05 Lbs
 - **Unmating**
 - **Min**-----6.55 Lbs
 - **Max**-----9.01 Lbs
- **After 75 Cycles**
 - **Mating**
 - **Min**-----6.95 Lbs
 - **Max**-----9.91 Lbs
 - **Unmating**
 - **Min**-----7.13 Lbs
 - **Max**-----10.00 Lbs
- **After 100 Cycles**
 - **Mating**
 - **Min**-----7.10 Lbs
 - **Max**-----10.58 Lbs
 - **Unmating**
 - **Min**-----7.45 Lbs
 - **Max**-----10.65 Lbs
- **Humidity**
 - **Mating**
 - **Min**-----6.30 Lbs
 - **Max**-----8.48 Lbs
 - **Unmating**
 - **Min**-----5.64 Lbs
 - **Max**-----7.27 Lbs

RESULTS Continued**Mating – Unmating Forces****Mating\Unmating Durability Group B2 (SQW-150-01-S-D-VS-A/TMM-150-01-S-D-SM)**

- **Initial**
 - **Mating**
 - **Min**-----13.98 Lbs
 - **Max**-----18.26Lbs
 - **Unmating**
 - **Min**-----13.22 Lbs
 - **Max**-----14.75 Lbs
- **After 25 Cycles**
 - **Mating**
 - **Min**-----14.05 Lbs
 - **Max**-----17.57 Lbs
 - **Unmating**
 - **Min**-----13.76 Lbs
 - **Max**-----17.16 Lbs
- **After 50 Cycles**
 - **Mating**
 - **Min**-----15.43 Lbs
 - **Max**-----17.83 Lbs
 - **Unmating**
 - **Min**-----14.86 Lbs
 - **Max**-----18.03 Lbs
- **After 75 Cycles**
 - **Mating**
 - **Min**-----16.10 Lbs
 - **Max**-----18.53 Lbs
 - **Unmating**
 - **Min**-----15.62 Lbs
 - **Max**-----18.58 Lbs
- **After 100 Cycles**
 - **Mating**
 - **Min**-----16.31 Lbs
 - **Max**-----19.98 Lbs
 - **Unmating**
 - **Min**-----16.28 Lbs
 - **Max**-----19.89 Lbs

RESULTS Continued**Mating – Unmating Forces****Mating\Unmating Durability Group B3 (SQW-105-01-S-D-VS-A/TMM-105-01-S-D-SM)**

- **Initial**
 - **Mating**
 - **Min**----- 1.28 Lbs
 - **Max**----- 1.57 Lbs
 - **Unmating**
 - **Min**----- 1.10 Lbs
 - **Max**----- 1.41 Lbs
- **After 25 Cycles**
 - **Mating**
 - **Min**----- 1.23 Lbs
 - **Max**----- 1.83 Lbs
 - **Unmating**
 - **Min**----- 1.11 Lbs
 - **Max**----- 2.02 Lbs
- **After 50 Cycles**
 - **Mating**
 - **Min**----- 1.26 Lbs
 - **Max**----- 2.09 Lbs
 - **Unmating**
 - **Min**----- 1.36 Lbs
 - **Max**----- 2.21 Lbs
- **After 75 Cycles**
 - **Mating**
 - **Min**----- 1.37 Lbs
 - **Max**----- 2.26 Lbs
 - **Unmating**
 - **Min**----- 1.49 Lbs
 - **Max**----- 2.45 Lbs
- **After 100 Cycles**
 - **Mating**
 - **Min**----- 1.65 Lbs
 - **Max**----- 2.40 Lbs
 - **Unmating**
 - **Min**----- 1.75 Lbs
 - **Max**----- 2.43 Lbs

Normal Force at 0.005 inch deflection

- **Initial**
 - **Min**-----76.40 gf **Set ---- 0.000 mm**
 - **Max**-----86.90 gf **Set ---- 0.000 mm**
- **Thermal**
 - **Min**-----84.30 gf **Set----- 0.000 mm**
 - **Max**-----98.40 gf **Set----- 0.000 mm**

RESULTS Continued**Insulation Resistance minimums, IR****Pin to Pin**

- **Initial**
 - Mated-----10000 Meg Ω -----Pass
 - Unmated -----10000 Meg Ω -----Pass
- **Thermal**
 - Mated-----10000 Meg Ω -----Pass
 - Unmated -----10000 Meg Ω -----Pass
- **Humidity**
 - Mated-----10000 Meg Ω -----Pass
 - Unmated -----10000 Meg Ω -----Pass

Dielectric Withstanding Voltage minimums, DWV

- **Minimums**
 - Breakdown Voltage----- 1125 VAC
 - Test Voltage -----844 VAC
 - Working Voltage -----281 VAC

Pin to Pin

- **Initial DWV**-----Passed
- **Thermal DWV**-----Passed
- **Humidity DWV**-----Passed

LLCR Gas Tight (192 LLCR test points)

- **Initial**-----8.9 mOhms Max
- **Gas-Tight**
 - $\leq +5.0$ mOhms ----- 192 Points ----- Stable
 - $+5.1$ to $+10.0$ mOhms -----0Points----- Minor
 - $+10.1$ to $+15.0$ mOhms -----0 Points----- Acceptable
 - $+15.1$ to $+50.0$ mOhms -----0 Points----- Marginal
 - $+50.1$ to $+2000$ mOhms-----0 Points----- Unstable
 - $>+2000$ mOhms-----0 Points----- Open Failure

LLCR Thermal Aging (192 LLCR test points)

- **Initial**-----8.8 mOhms Max
- **Thermal**
 - $\leq +5.0$ mOhms ----- 192 Points ----- Stable
 - $+5.1$ to $+10.0$ mOhms -----0 Points----- Minor
 - $+10.1$ to $+15.0$ mOhms -----0 Points----- Acceptable
 - $+15.1$ to $+50.0$ mOhms -----0 Points----- Marginal
 - $+50.1$ to $+2000$ mOhms-----0 Points----- Unstable
 - $>+2000$ mOhms-----0 Points----- Open Failure

RESULTS Continued**LLCR Durability (192 LLCR test points)**

- **Initial**-----9.0 mOhms Max
- **Durability, 100 Cycles**
 - <= +5.0 mOhms ----- 192 Points ----- Stable
 - +5.1 to +10.0 mOhms ----- 0 Points ----- Minor
 - +10.1 to +15.0 mOhms ----- 0 Points ----- Acceptable
 - +15.1 to +50.0 mOhms ----- 0 Points ----- Marginal
 - +50.1 to +2000 mOhms ----- 0 Points ----- Unstable
 - >+2000 mOhms ----- 0 Points ----- Open Failure
- **Thermal**
 - <= +5.0 mOhms ----- 192 Points ----- Stable
 - +5.1 to +10.0 mOhms ----- 0 Points ----- Minor
 - +10.1 to +15.0 mOhms ----- 0 Points ----- Acceptable
 - +15.1 to +50.0 mOhms ----- 0 Points ----- Marginal
 - +50.1 to +2000 mOhms ----- 0 Points ----- Unstable
 - >+2000 mOhms ----- 0 Points ----- Open Failure
- **Humidity**
 - <= +5.0 mOhms ----- 192 Points ----- Stable
 - +5.1 to +10.0 mOhms ----- 0 Points ----- Minor
 - +10.1 to +15.0 mOhms ----- 0 Points ----- Acceptable
 - +15.1 to +50.0 mOhms ----- 0 Points ----- Marginal
 - +50.1 to +2000 mOhms ----- 0 Points ----- Unstable
 - >+2000 mOhms ----- 0 Points ----- Open Failure

LLCR Mechanical Shock & Random Vibration (192 LLCR test points)

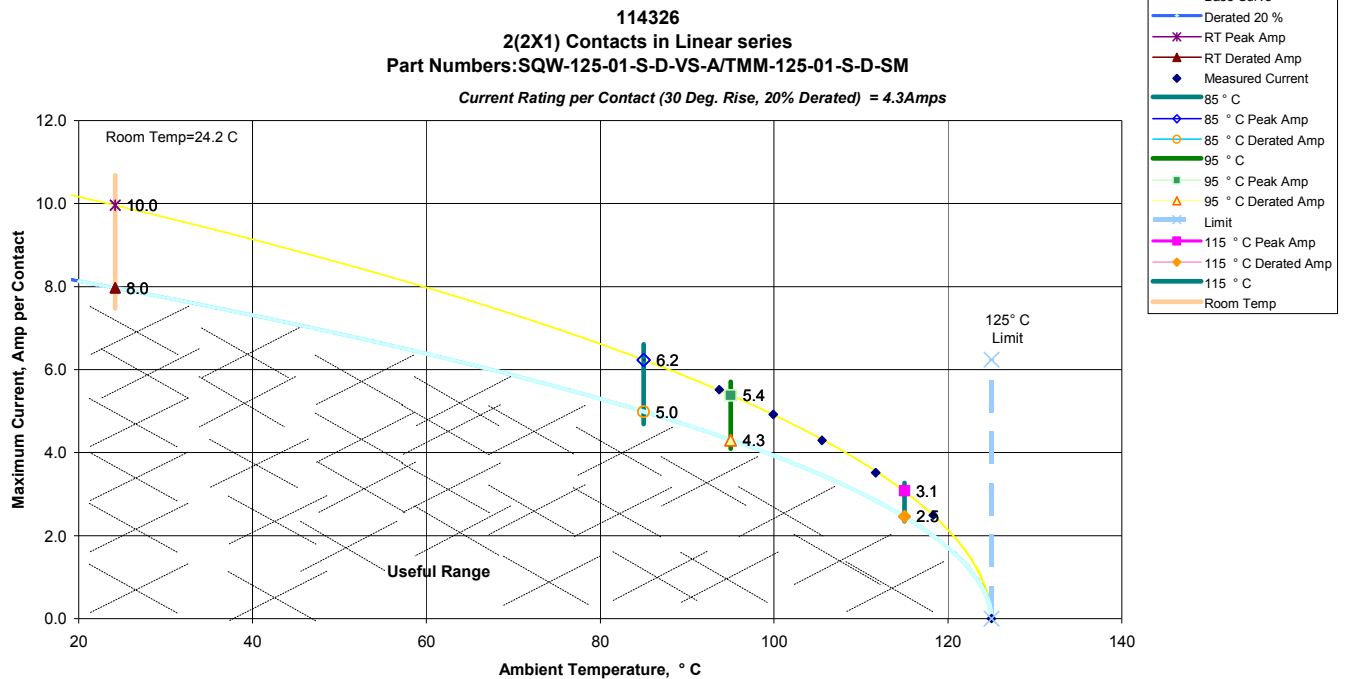
- **Initial**-----8.8 mOhms Max
- **Shock & Vibration**
 - <= +5.0 mOhms ----- 191 Points ----- Stable
 - +5.1 to +10.0 mOhms ----- 1 Points ----- Minor
 - +10.1 to +15.0 mOhms ----- 0 Points ----- Acceptable
 - +15.1 to +50.0 mOhms ----- 0 Points ----- Marginal
 - +50.1 to +2000 mOhms ----- 0 Points ----- Unstable
 - >+2000 mOhms ----- 0 Points ----- Open Failure

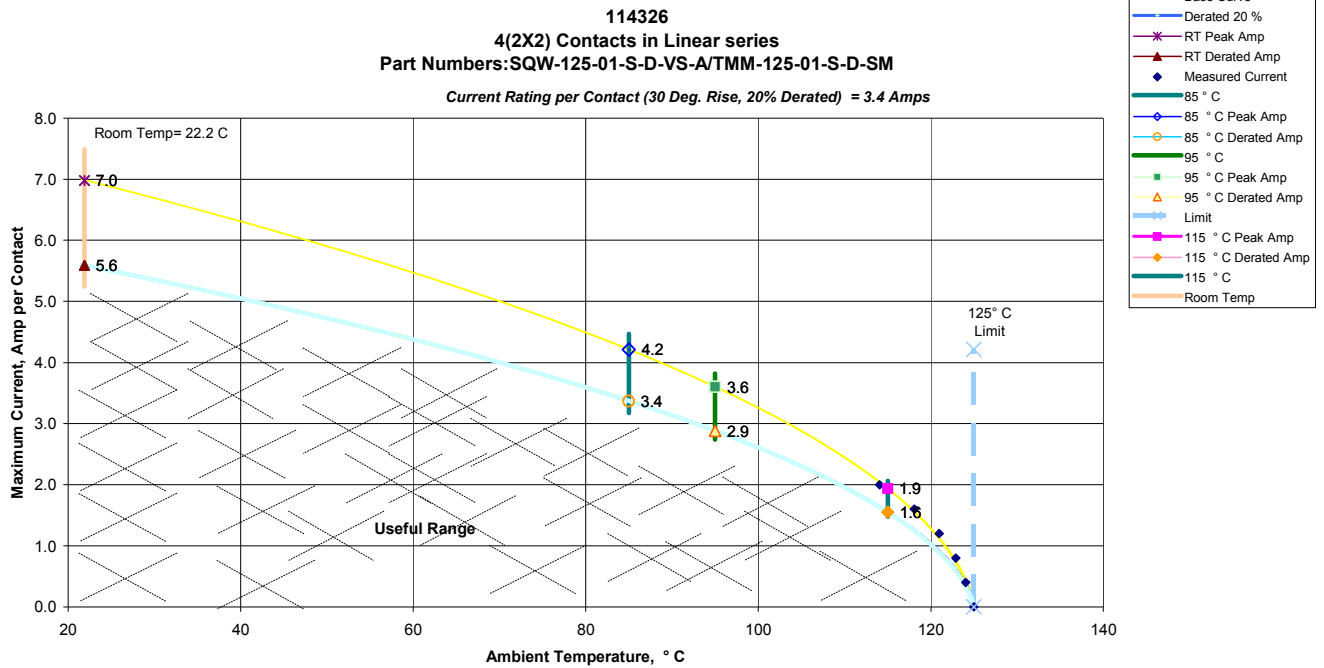
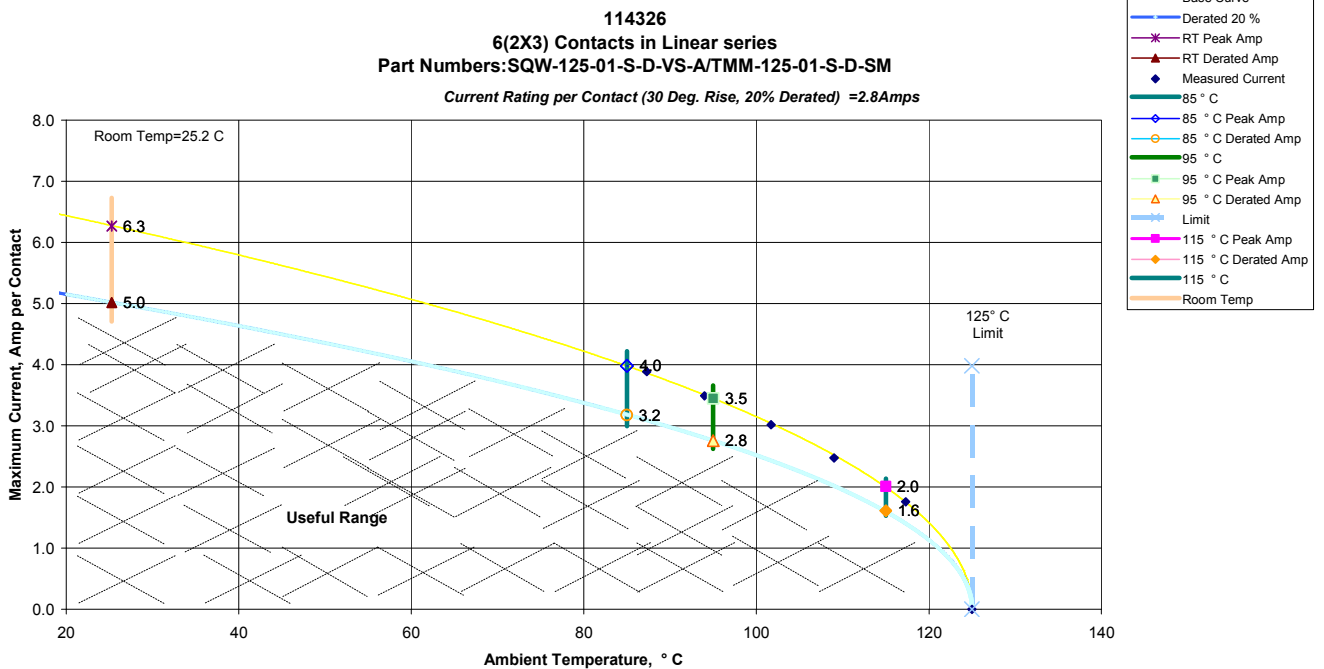
Mechanical Shock & Random Vibration:

- **Shock**
 - No Damage----- Passed
 - 50 Nanoseconds----- Passed
- **Vibration**
 - No Damage----- Passed
 - 50 Nanoseconds----- Passed

DATA SUMMARIES**TEMPERATURE RISE (Current Carrying Capacity, CCC):**

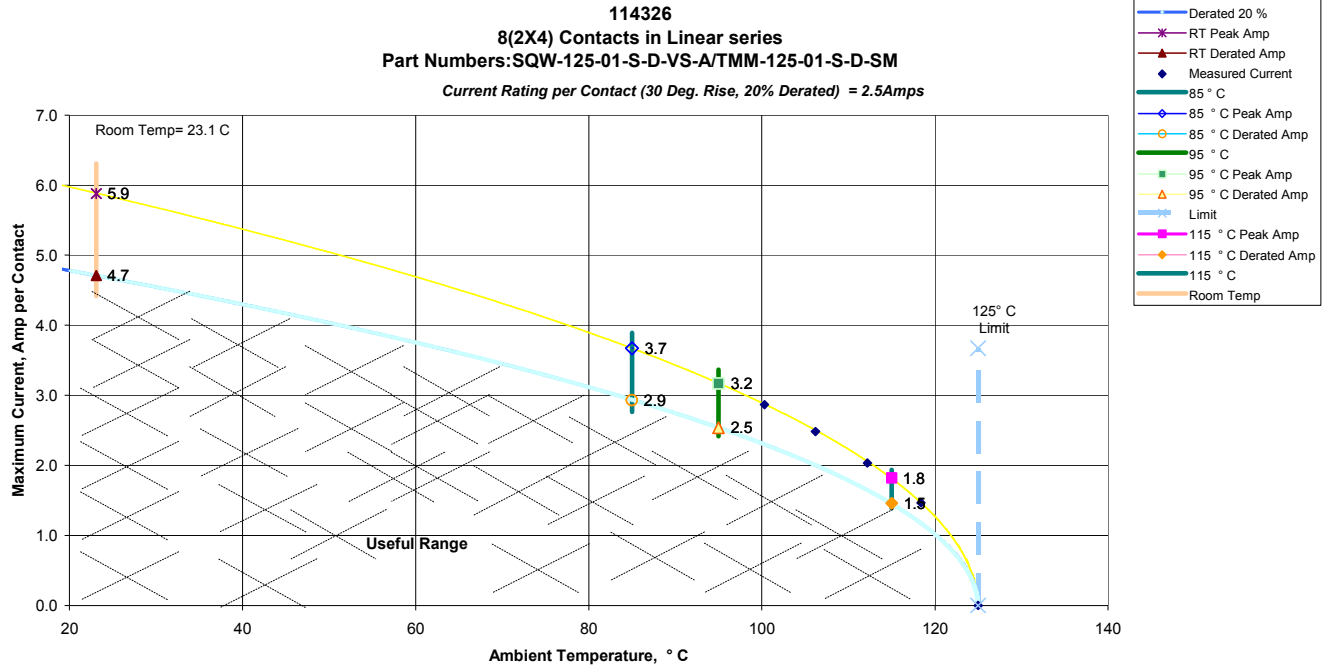
- 1) High quality thermocouples whose temperature slopes track one another were used for temperature monitoring.
- 2) The thermocouples were placed at a location to sense the maximum temperature generated during testing.
- 3) Temperature readings recorded are those for which three successive readings, 15 minutes apart, differ less than 1° C (computer controlled data acquisition).
- 4) Adjacent contacts were powered:
 - a. Linear configuration with 2 adjacent conductors/contacts powered



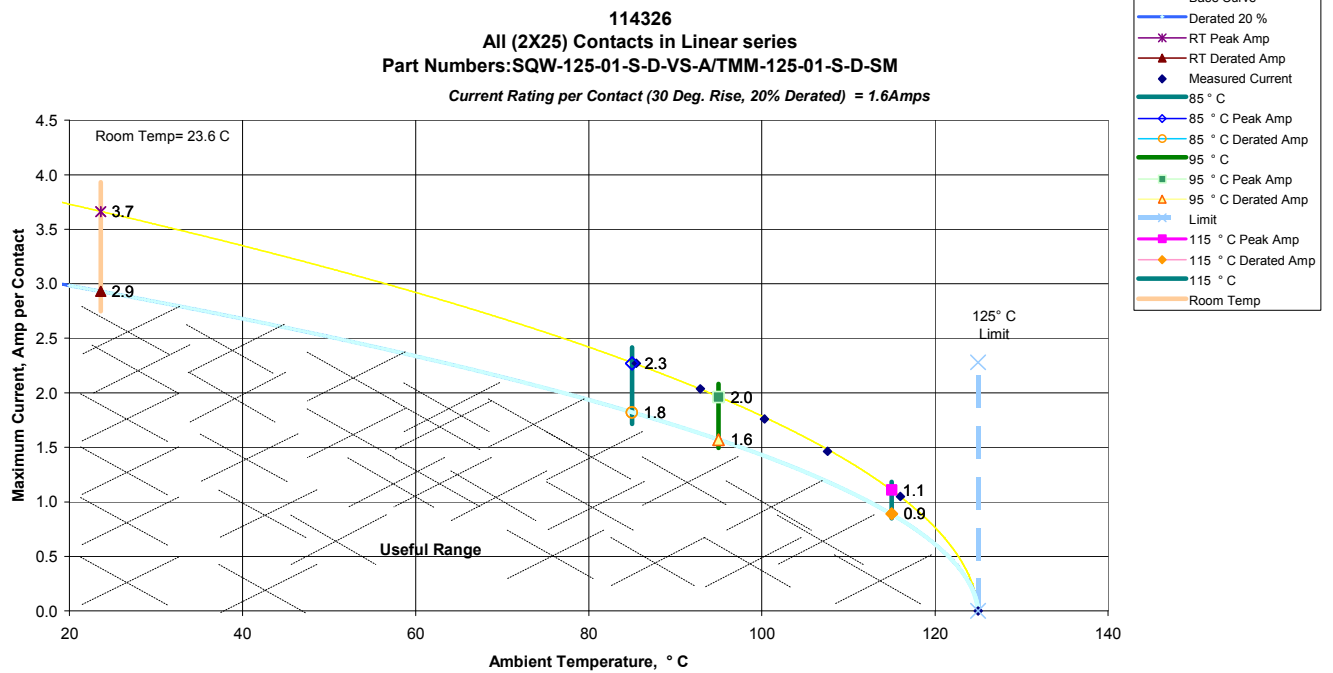
DATA SUMMARIES Continued**b. Linear configuration with 4 adjacent conductors/contacts powered****c. Linear configuration with 6 adjacent conductors/contacts powered**

DATA SUMMARIES Continued

d. Linear configuration with 8 adjacent conductors/contacts powered



e. Linear configuration with all adjacent conductors/contacts powered



DATA SUMMARIES Continued**CONTACT GAPS:****Normal Force Group****Group A1**

Initial	
Units:	mm
<i>Minimum</i>	0.2500
<i>Maximum</i>	0.2660
<i>Average</i>	0.2588
<i>St. Dev.</i>	0.0064
<i>Count</i>	8

Group A2

Initial		After Thermal	
Units:	mm	Units:	mm
<i>Minimum</i>	0.2500	<i>Minimum</i>	0.2760
<i>Maximum</i>	0.2660	<i>Maximum</i>	0.2840
<i>Average</i>	0.2613	<i>Average</i>	0.2796
<i>St. Dev.</i>	0.0055	<i>St. Dev.</i>	0.0028
<i>Count</i>	8	<i>Count</i>	8

Thermal Aging Group

Initial		After Thermal	
Units:	mm	Units:	mm
<i>Minimum</i>	0.2480	<i>Minimum</i>	0.2760
<i>Maximum</i>	0.3200	<i>Maximum</i>	0.3140
<i>Average</i>	0.2772	<i>Average</i>	0.2958
<i>St. Dev.</i>	0.0129	<i>St. Dev.</i>	0.0075
<i>Count</i>	64	<i>Count</i>	64

Mating\Unmating Durability Group

Initial		After 100 Cycles	
Units:	mm	Units:	mm
<i>Minimum</i>	0.2560	<i>Minimum</i>	0.2560
<i>Maximum</i>	0.2840	<i>Maximum</i>	0.2940
<i>Average</i>	0.2716	<i>Average</i>	0.2754
<i>St. Dev.</i>	0.0076	<i>St. Dev.</i>	0.0092
<i>Count</i>	64	<i>Count</i>	64

DATA SUMMARIES Continued

MATING/UNMATING:

Thermal Aging Group

	Initial				After Thermals			
	Mating		Unmating		Mating		Unmating	
	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)
Minimum	31.89	7.17	22.55	5.07	23.35	5.25	21.35	4.80
Maximum	41.77	9.39	31.31	7.04	36.78	8.27	28.42	6.39
Average	34.51	7.76	27.26	6.13	31.36	7.05	25.52	5.74
St Dev	3.15	0.71	2.56	0.58	4.35	0.98	2.38	0.54
Count	8	8	8	8	8	8	8	8

Mating\Unmating Durability Group

	Initial				After 25 Cycles			
	Mating		Unmating		Mating		Unmating	
	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)
Minimum	29.09	6.54	22.55	5.07	29.40	6.61	25.84	5.81
Maximum	35.85	8.06	26.95	6.06	37.90	8.52	35.72	8.03
Average	32.93	7.40	24.61	5.53	34.22	7.69	30.71	6.91
St Dev	2.21	0.50	1.57	0.35	3.54	0.80	3.24	0.73
Count	8	8	8	8	8	8	8	8
	After 50 Cycles				After 75 Cycles			
	Mating		Unmating		Mating		Unmating	
	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)
Minimum	30.29	6.81	29.13	6.55	30.91	6.95	31.71	7.13
Maximum	40.25	9.05	40.08	9.01	44.08	9.91	44.48	10.00
Average	35.14	7.90	34.78	7.82	36.91	8.30	36.70	8.25
St Dev	3.54	0.80	3.64	0.82	4.26	0.96	4.09	0.92
Count	8	8	8	8	8	8	8	8
	After 100 Cycles				After Humidity			
	Mating		Unmating		Mating		Unmating	
	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)
Minimum	31.58	7.10	33.14	7.45	28.02	6.30	25.09	5.64
Maximum	47.06	10.58	47.37	10.65	37.72	8.48	32.34	7.27
Average	38.89	8.74	39.38	8.85	31.38	7.05	27.37	6.15
St Dev	4.81	1.08	4.70	1.06	3.16	0.71	2.65	0.59
Count	8	8	8	8	8	8	8	8

DATA SUMMARIES Continued**NORMAL FORCE (FOR CONTACTS TESTED OUTSIDE THE HOUSING):**

- 1) Calibrated force gauges are used along with computer controlled positioning equipment.
- 2) For Normal force 8-10 measurements are taken and the averages reported.

Initial	Deflections in inches Forces in Grams				
	<u>0.0020</u>	<u>0.0030</u>	<u>0.0040</u>	<u>0.0050</u>	<u>SET</u>
Averages	34.48	50.44	66.19	82.81	0.0000
Min	30.80	46.20	60.00	76.40	0.0000
Max	39.70	54.80	69.90	86.90	0.0000
St. Dev	2.666	2.879	2.912	3.385	0.0000
Count	12	12	12	12	12

After Thermals	Deflections in inches Forces in Grams				
	<u>0.0020</u>	<u>0.0030</u>	<u>0.0040</u>	<u>0.0050</u>	<u>SET</u>
Averages	37.80	55.28	71.99	89.68	0.0000
Min	32.50	51.50	67.30	84.30	0.0000
Max	44.00	62.70	81.40	98.40	0.0000
St. Dev	3.044	3.260	3.899	3.881	0.0000
Count	12	12	12	12	12

INSULATION RESISTANCE (IR):

	Pin to Pin		
	Mated	Unmated	Unmated
Minimum	SQW/TMM	SQW	TMM
Initial	10000	10000	10000
Thermal	10000	10000	10000
Humidity	10000	10000	10000

DIELECTRIC WITHSTANDING VOLTAGE (DWV):

Voltage Rating Summary	
Minimum	SQW/TMM
Break Down Voltage	1125
Test Voltage	844
Working Voltage	281

Pin to Pin	
Initial Test Voltage	Passed
After Thermal Test Voltage	Passed
After Humidity Test Voltage	Passed

DATA SUMMARIES Continued**LLCR Durability:**

- 1) A total of 192 points were measured.
- 2) EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets*.
- 3) A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
- 4) The following guidelines are used to categorize the changes in LLCR as a result from stressing.
 - a. $\leq +5.0$ mOhms: -----Stable
 - b. $+5.1$ to $+10.0$ mOhms:-----Minor
 - c. $+10.1$ to $+15.0$ mOhms: -----Acceptable
 - d. $+15.1$ to $+50.0$ mOhms: -----Marginal
 - e. $+50.1$ to $+2000$ mOhms -----Unstable
 - f. $>+2000$ mOhms:-----Open Failure

Date	3/18/2011	3/28/2011	4/2/2011	4/12/2011
Room Temp C	22	23	25	24
RH	53%	50%	48%	49%
Name	Vico	Vico	Vico	Vico
mOhm values	Actual Initial	Delta 100 Cycles	Delta Thermal	Delta Humidity
Average	7.8	-0.1	-0.2	-0.1
St. Dev.	0.3	0.2	0.2	0.2
Min	7.1	-0.7	-0.8	-0.8
Max	9.0	0.5	0.4	0.8
Count	192	192	192	192

How many samples are being tested?

8

How many contacts are on each board?

24

	Stable	Minor	Acceptable	Marginal	Unstable	Open
100 Cycles	192	0	0	0	0	0
Thermal	192	0	0	0	0	0
Humidity	192	0	0	0	0	0

Tracking Code: 114326_Report_Rev_1	Part #: SQW-125-01-S-D-VS-A/TMM-125-01-S-D-SM
Part description: SQW/TMM	

DATA SUMMARIES Continued

LLCR Thermal:

- 1) A total of 192 points were measured.
- 2) EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets*.
- 3) A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
- 4) The following guidelines are used to categorize the changes in LLCR as a result from stressing.
 - a. $\leq +5.0$ mOhms: -----Stable
 - b. $+5.1$ to $+10.0$ mOhms:-----Minor
 - c. $+10.1$ to $+15.0$ mOhms: -----Acceptable
 - d. $+15.1$ to $+50.0$ mOhms: -----Marginal
 - e. $+50.1$ to $+2000$ mOhms -----Unstable
 - f. $>+2000$ mOhms:-----Open Failure

Date	3/23/2011	4/6/2011
Room Temp C	22	21
RH	50%	52%
Name	Vico	Vico
mOhm values	Actual Initial	Delta Thermal Age
Average	7.7	0.1
St. Dev.	0.4	0.2
Min	6.9	-0.5
Max	8.8	1.1
Count	192	192

How many samples are being tested?	<u>8</u>
How many contacts are on each board?	<u>24</u>

	Stable	Minor	Acceptable	Marginal	Unstable	Open
Thermal Age	192	0	0	0	0	0

DATA SUMMARIES Continued**GAS TIGHT:**

- 1) A total of 192 points were measured.
- 2) EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets*.
- 3) A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
- 4) The following guidelines are used to categorize the changes in LLCR as a result from stressing.
 - a. $\leq +5.0$ mOhms: -----Stable
 - b. $+5.1$ to $+10.0$ mOhms:-----Minor
 - c. $+10.1$ to $+15.0$ mOhms: -----Acceptable
 - d. $+15.1$ to $+50.0$ mOhms: -----Marginal
 - e. $+50.1$ to $+2000$ mOhms: -----Unstable
 - f. $>+2000$ mOhms:-----Open Failure

Date	4/1/2011	4/1/2011
Room Temp C	22	22
RH	45%	43%
Name	Vico	Vico
mOhm values	Actual Initial	Delta Gas Tight
Average	7.8	0.1
St. Dev.	0.3	0.2
Min	7.2	-0.2
Max	8.9	0.8
Count	192	192

How many samples are being tested?

8

How many contacts are on each board?

24

	Stable	Minor	Acceptable	Marginal	Unstable	Open
Gas Tight	192	0	0	0	0	0

DATA SUMMARIES Continued**LLCR Shock & Vibration:**

- 1) A total of 192 points were measured.
- 2) EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets*.
- 3) A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
- 4) The following guidelines are used to categorize the changes in LLCR as a result from stressing.
 - a. $\leq +5.0$ mOhms: -----Stable
 - b. $+5.1$ to $+10.0$ mOhms:-----Minor
 - c. $+10.1$ to $+15.0$ mOhms: -----Acceptable
 - d. $+15.1$ to $+50.0$ mOhms: -----Marginal
 - e. $+50.1$ to $+2000$ mOhms -----Unstable
 - f. $>+2000$ mOhms:-----Open Failure

Date	5/5/2011	5/24/2011
Room Temp C	23	23
RH	32%	59%
Name	Aaron McKim	Aaron McKim
mOhm values	Actual Initial	Delta Shock / Vibe
Average	7.8	0.0
St. Dev.	0.4	0.7
Min	6.9	-0.8
Max	8.8	6.0
Count	192	192

How many samples are being tested?

8

How many contacts are on each board?

24

	Stable	Minor	Acceptable	Marginal	Unstable	Open
Shock / Vibe	191	1	0	0	0	0

Nanosecond Event Detection:

Shock and Vibration Event Detection Summary	
Contacts tested	60
Test Condition	C, 100g's, 6ms, Half-Sine
Shock Events	0
Test Condition	V-B, 7.56 rms g
Vibration Events	0
Total Events	0

DATA**CONTACT GAPS:****Normal Force Group****Group A1**

Initial	
Units:	mm
Pos.#	B1
1	0.2660
2	0.2500
3	0.2540
4	0.2660
5	0.2580
6	0.2560
7	0.2660
8	0.2540

Group A2

Initial	
Units:	mm
Pos.#	B1
1	0.2500
2	0.2640
3	0.2660
4	0.2580
5	0.2660
6	0.2640
7	0.2580
8	0.2640
After 25 Cycles	
Units:	mm
Pos.#	B1
1	0.2760
2	0.2810
3	0.2780
4	0.2800
5	0.2820
6	0.2840
7	0.2800
8	0.2760

DATA Continued**Thermal Aging Group**

Initial	
Units:	mm
Pos.#	B1
1	0.2960
2	0.2800
3	0.2880
4	0.2780
5	0.2740
6	0.2880
7	0.2740
8	0.2780
9	0.2760
10	0.2720
11	0.2820
12	0.2800
13	0.2800
14	0.2840
15	0.2900
16	0.2800
17	0.2860
18	0.2820
19	0.2920
20	0.2780
21	0.2900
22	0.2780
23	0.2720
24	0.2900
25	0.2800
26	0.2820
27	0.2920
28	0.2820
29	0.2820
30	0.2860
31	0.2860
32	0.2740
33	0.2800
34	0.2600
35	0.2840
36	0.2620
37	0.2960
38	0.2620
39	0.2860
40	0.2620
41	0.2680
42	0.2600
43	0.2760

Tracking Code: 114326_Report_Rev_1	Part #: SQW-125-01-S-D-VS-A/TMM-125-01-S-D-SM
Part description: SQW/TMM	

44	0.2480
45	0.2620
46	0.2620
47	0.2660
48	0.2620
49	0.2760
50	0.2760
51	0.2860
52	0.2700
53	0.3200
54	0.3160
55	0.2680
56	0.2620
57	0.2760
58	0.2640
59	0.2640
60	0.2660
61	0.2600
62	0.2780
63	0.2600
64	0.2680
After 100 Cycles	
Units:	mm
Pos.#	B1
1	0.3000
2	0.3000
3	0.2940
4	0.2900
5	0.2920
6	0.2860
7	0.2880
8	0.3040
9	0.2960
10	0.2880
11	0.2980
12	0.2980
13	0.2980
14	0.3000
15	0.3060
16	0.2980
17	0.3060
18	0.2940
19	0.3040
20	0.2860
21	0.2980
22	0.2940
23	0.2980
24	0.3020
25	0.2970

Tracking Code: 114326_Report_Rev_1

Part #: SQW-125-01-S-D-VS-A/TMM-125-01-S-D-SM

Part description: SQW/TMM

26	0.3010
27	0.3140
28	0.3070
29	0.2980
30	0.2870
31	0.2960
32	0.2970
33	0.2880
34	0.2960
35	0.2790
36	0.2940
37	0.3120
38	0.2920
39	0.2880
40	0.2940
41	0.2980
42	0.2840
43	0.2760
44	0.2920
45	0.2880
46	0.3060
47	0.2960
48	0.3020
49	0.2920
50	0.2920
51	0.2960
52	0.3040
53	0.3060
54	0.3020
55	0.3020
56	0.3000
57	0.2880
58	0.2960
59	0.2900
60	0.2980
61	0.3000
62	0.2880
63	0.2980
64	0.2820

DATA Continued**Mating\Unmating Durability Group**

Initial	
Units:	mm
Pos.#	B1
1	0.2820
2	0.2580
3	0.2800
4	0.2620
5	0.2720
6	0.2620
7	0.2800
8	0.2780
9	0.2680
10	0.2720
11	0.2720
12	0.2700
13	0.2620
14	0.2620
15	0.2720
16	0.2620
17	0.2600
18	0.2840
19	0.2560
20	0.2720
21	0.2560
22	0.2740
23	0.2620
24	0.2740
25	0.2720
26	0.2740
27	0.2740
28	0.2820
29	0.2720
30	0.2680
31	0.2720
32	0.2600
33	0.2680
34	0.2800
35	0.2700
36	0.2660
37	0.2820
38	0.2620
39	0.2780
40	0.2640
41	0.2820
42	0.2660
43	0.2760

Tracking Code: 114326_Report_Rev_1	Part #: SQW-125-01-S-D-VS-A/TMM-125-01-S-D-SM
Part description: SQW/TMM	

44	0.2760
45	0.2760
46	0.2760
47	0.2740
48	0.2700
49	0.2820
50	0.2700
51	0.2780
52	0.2660
53	0.2660
54	0.2700
55	0.2800
56	0.2720
57	0.2620
58	0.2740
59	0.2800
60	0.2840
61	0.2780
62	0.2820
63	0.2660
64	0.2820
After 100 Cycles	
Units:	mm
Pos.#	B1
1	0.2920
2	0.2600
3	0.2800
4	0.2820
5	0.2820
6	0.2820
7	0.2800
8	0.2640
9	0.2760
10	0.2660
11	0.2680
12	0.2760
13	0.2700
14	0.2640
15	0.2740
16	0.2560
17	0.2740
18	0.2820
19	0.2660
20	0.2920
21	0.2680
22	0.2820
23	0.2680
24	0.2660
25	0.2760

Tracking Code: 114326_Report_Rev_1

Part #: SQW-125-01-S-D-VS-A/TMM-125-01-S-D-SM

Part description: SQW/TMM

26	0.2640
27	0.2700
28	0.2780
29	0.2760
30	0.2660
31	0.2740
32	0.2740
33	0.2800
34	0.2820
35	0.2680
36	0.2700
37	0.2920
38	0.2680
39	0.2900
40	0.2720
41	0.2880
42	0.2640
43	0.2860
44	0.2680
45	0.2940
46	0.2720
47	0.2880
48	0.2640
49	0.2840
50	0.2640
51	0.2780
52	0.2760
53	0.2840
54	0.2800
55	0.2700
56	0.2760
57	0.2820
58	0.2820
59	0.2580
60	0.2740
61	0.2800
62	0.2940
63	0.2760
64	0.2720

DATA Continued**MATING/UNMATING:****Thermal Aging Group**

<u>Sample#</u>	Initial		After Thermals	
	<u>Mating</u>	<u>Unmating</u>	<u>Mating</u>	<u>Unmating</u>
1	7.61	5.89	6.33	5.51
2	7.17	6.06	5.25	5.24
3	7.72	6.22	7.32	5.89
4	7.31	5.87	6.85	5.73
5	7.39	5.07	6.75	4.80
6	9.39	7.04	8.27	6.39
7	7.99	6.31	7.66	6.11
8	7.48	6.57	7.98	6.23

Mating\Unmating Durability Group B1 (SQW-125-01-S-D-VS-A/TMM-125-01-S-D-SM)

<u>Sample#</u>	Initial		After 25 Cycles		After 50 Cycles		After 75 Cycles		After 100 Cycles	
	<u>Mating</u>	<u>Unmating</u>	<u>Mating</u>	<u>Unmating</u>	<u>Mating</u>	<u>Unmating</u>	<u>Mating</u>	<u>Unmating</u>	<u>Mating</u>	<u>Unmating</u>
1	7.55	5.67	7.27	7.17	7.45	7.75	8.03	8.18	8.42	8.84
2	7.35	5.45	7.92	7.53	8.15	8.62	8.41	8.84	9.23	9.72
3	6.54	5.07	6.61	5.81	6.81	6.55	6.95	7.13	7.10	7.45
4	7.00	5.16	6.67	6.14	7.06	6.88	7.29	7.13	7.62	7.54
5	7.34	5.40	8.52	6.72	8.04	7.78	8.23	8.27	8.77	8.93
6	8.00	5.98	8.48	7.21	8.86	7.78	9.25	8.19	9.45	8.60
7	7.39	5.48	7.56	6.63	7.78	8.19	8.32	8.27	8.77	9.09
8	8.06	6.06	8.51	8.03	9.05	9.01	9.91	10.00	10.58	10.65

<u>Sample#</u>	After 100 Cycles		After Humidity	
	<u>Mating</u>	<u>Unmating</u>	<u>Mating</u>	<u>Unmating</u>
1	8.42	8.84	7.60	6.50
2	9.23	9.72	8.48	7.27
3	7.10	7.45	6.79	5.74
4	7.62	7.54	6.30	5.64
5	8.77	8.93	6.34	5.65
6	9.45	8.60	6.84	5.83
7	8.77	9.09	7.06	5.93
8	10.58	10.65	7.02	6.67

DATA Continued**Mating\Unmating Durability Group B2 (SQW-150-01-S-D-VS-A/TMM-150-01-S-D-SM)**

<u>Sample#</u>	Initial		After 25 Cycles		After 50 Cycles		After 75 Cycles		After 100 Cycles	
	Mating	Unmating	Mating	Unmating	Mating	Unmating	Mating	Unmating	Mating	Unmating
1	13.98	13.22	14.05	13.76	15.43	14.86	16.38	15.73	17.31	17.05
2	16.71	13.98	15.55	15.30	16.77	16.50	17.90	17.37	18.84	18.58
3	17.24	13.76	16.29	15.62	17.29	16.94	18.28	18.36	19.00	18.47
4	17.88	13.33	15.95	14.20	15.87	15.19	16.10	15.62	16.31	16.28
5	17.61	13.98	16.10	16.60	17.49	17.70	18.53	18.58	19.25	19.89
6	17.93	13.87	16.74	14.87	17.17	16.06	17.68	16.94	17.98	17.70
7	18.26	14.75	16.99	17.16	17.07	18.03	18.38	18.36	19.98	19.01
8	18.01	14.26	17.57	16.32	17.83	16.97	17.92	17.35	18.59	18.47

Mating\Unmating Durability Group B3 (SQW-105-01-S-D-VS-A/TMM-105-01-S-D-SM)

<u>Sample#</u>	Initial		After 25 Cycles		After 50 Cycles		After 75 Cycles		After 100 Cycles	
	Mating	Unmating	Mating	Unmating	Mating	Unmating	Mating	Unmating	Mating	Unmating
1	1.48	1.36	1.51	1.63	1.65	1.74	1.76	1.91	1.84	1.93
2	1.33	1.34	1.48	1.63	1.64	1.77	1.81	1.93	1.71	1.85
3	1.57	1.35	1.83	2.02	2.09	2.10	2.26	2.45	2.40	2.43
4	1.51	1.41	1.61	1.77	1.78	1.93	1.85	2.02	1.97	2.13
5	1.45	1.33	1.54	1.66	1.74	1.91	1.77	1.88	1.95	2.04
6	1.45	1.24	1.42	1.36	1.72	1.83	1.72	1.85	1.92	2.03
7	1.28	1.10	1.23	1.11	1.26	1.36	1.37	1.49	1.65	1.75
8	1.50	1.28	1.74	1.82	2.06	2.21	2.13	2.29	2.24	2.34

DATA Continued**NORMAL FORCE (FOR CONTACTS TESTED OUTSIDE THE HOUSING):**

Initial Sample #	Deflections in inches Forces in Grams				
	<u>0.0020</u>	<u>0.0030</u>	<u>0.0040</u>	<u>0.0050</u>	<u>SET</u>
1	37.1	54.8	68.9	85.0	0.0000
2	33.8	50.2	67.3	83.0	0.0000
3	34.1	50.5	66.9	84.7	0.0000
4	33.1	48.9	64.6	80.7	0.0000
5	31.5	46.2	60.0	77.8	0.0000
6	39.7	54.8	69.9	85.0	0.0000
7	38.0	53.5	68.6	86.9	0.0000
8	33.4	50.2	67.9	85.6	0.0000
9	34.1	49.9	66.3	83.3	0.0000
10	32.5	47.9	63.6	79.7	0.0000
11	30.8	46.6	62.7	76.4	0.0000
12	35.7	51.8	67.6	85.6	0.0000

After Thermals Sample #	Deflections in inches, Forces in Grams				
	<u>0.0020</u>	<u>0.0030</u>	<u>0.0040</u>	<u>0.0050</u>	<u>SET</u>
1	36.7	54.8	70.2	89.6	0.0000
2	38.7	53.8	69.9	86.9	0.0000
3	35.7	52.8	67.3	84.3	0.0000
4	35.7	53.5	72.2	90.9	0.0000
5	32.5	51.5	69.6	88.3	0.0000
6	36.4	52.8	69.9	87.3	0.0000
7	37.1	53.5	69.2	87.6	0.0000
8	42.0	60.0	77.4	95.8	0.0000
9	36.7	54.8	71.2	89.6	0.0000
10	44.0	62.7	81.4	98.4	0.0000
11	38.7	57.1	72.8	88.3	0.0000
12	39.4	56.1	72.8	89.2	0.0000

DATA Continued**INSULATION RESISTANCE (IR):**

Initial Insulation Resistance	
Measured In Meg Ohms	

Pin to Pin			
Mated		A	Unmated B
x		x	x
Sample#	SQW/TMM	SQW	TMM
114326-031	10000	10000	10000
114326-032	10000	10000	10000

Thermal Insulation Resistance	
Measured In Meg Ohms	

Pin to Pin			
Mated		A	Unmated B
X		X	X
Sample#	SQW/TMM	SQW	TMM
114326-031	10000	10000	10000
114326-032	10000	10000	10000

Humidity Insulation Resistance	
Measured In Meg Ohms	

Pin to Pin			
Mated		A	Unmated B
x		x	x
Sample#	SQW/TMM	SQW	TMM
114326-031	10000	10000	10000
114326-032	10000	10000	10000

DATA Continued**DIELECTRIC WITHSTANDING VOLTAGE (DWV):**

Initial Breakdown Voltage			
Test Voltage <i>Until Breakdown Occurs</i>			
Pin to Pin			
Mated		A	Unmated B
X			
Sample#	SQW/TMM	SQW	TMM
114326-027	1125	1125	1500
114326-028	1125	1125	1500

Initial DWV			
Test Voltage= 844			
Pin to Pin			
Mated		A	Unmated B
Sample#	SQW/TMM	SQW	TMM
114326-031	844	844	844
114326-032	844	844	844

Thermal Test Voltage			
Test Voltage= 844			
Pin to Pin			
Mated		A	Unmated B
Sample#	SQW/TMM	SQW	TMM
114326-031	844	844	844
114326-032	844	844	844

Humidity Test Voltage			
Test Voltage= 844			
Pin to Pin			
Mated		A	Unmated B
Sample#	SQW/TMM	SQW	TMM
114326-031	844	844	844
114326-032	844	844	844

DATA Continued**GAS TIGHT:**

	mOhm values	Actual	Delta
Board	Position	Initial	Gas Tight
1	P1	7.7	0.4
1	P2	7.5	0.0
1	P3	7.5	0.0
1	P4	7.7	0.3
1	P5	7.8	0.0
1	P6	8.0	0.8
1	P7	7.8	0.0
1	P8	8.0	0.1
1	P9	7.9	0.4
1	P10	8.0	0.4
1	P11	7.7	0.6
1	P12	7.8	0.5
1	P13	7.8	0.1
1	P14	7.8	0.1
1	P15	7.6	0.2
1	P16	8.0	0.1
1	P17	7.7	0.3
1	P18	8.0	0.1
1	P19	7.7	0.2
1	P20	7.9	0.1
1	P21	7.8	0.3
1	P22	8.0	0.3
1	P23	7.9	0.1
1	P24	7.4	0.5
2	P1	7.9	0.2
2	P2	8.0	0.0
2	P3	8.1	-0.2
2	P4	8.2	-0.2
2	P5	7.8	0.2
2	P6	8.3	-0.1
2	P7	8.2	-0.2
2	P8	8.2	0.1
2	P9	8.0	0.0
2	P10	7.9	0.5
2	P11	8.2	0.0
2	P12	7.8	0.5
2	P13	8.1	-0.1
2	P14	8.3	0.0
2	P15	7.9	-0.1
2	P16	8.1	-0.1
2	P17	8.2	-0.1
2	P18	8.1	-0.1
2	P19	7.8	0.0

2	P20	8.3	-0.1
2	P21	8.0	0.0
2	P22	8.1	-0.2
2	P23	8.1	0.0
2	P24	8.1	0.7
3	P1	7.3	0.0
3	P2	7.3	0.3
3	P3	7.3	0.2
3	P4	7.5	0.2
3	P5	7.4	0.0
3	P6	7.4	0.2
3	P7	7.6	-0.1
3	P8	7.6	0.2
3	P9	7.5	0.1
3	P10	7.6	0.2
3	P11	7.5	0.1
3	P12	7.6	0.2
3	P13	7.6	0.0
3	P14	7.6	0.1
3	P15	7.5	0.1
3	P16	7.4	0.1
3	P17	7.4	0.0
3	P18	7.3	0.1
3	P19	7.3	0.2
3	P20	7.7	0.1
3	P21	7.5	0.2
3	P22	7.4	0.1
3	P23	7.3	0.2
3	P24	7.3	0.2
4	P1	7.6	0.1
4	P2	8.0	-0.2
4	P3	7.5	0.2
4	P4	8.2	0.3
4	P5	7.7	0.1
4	P6	8.1	0.1
4	P7	7.5	0.1
4	P8	8.5	0.1
4	P9	7.5	0.2
4	P10	8.2	0.1
4	P11	7.5	0.2
4	P12	8.1	0.1
4	P13	7.5	0.1
4	P14	8.3	-0.1
4	P15	7.4	0.1
4	P16	8.2	0.2
4	P17	7.6	-0.1
4	P18	7.7	0.6
4	P19	7.6	0.0
4	P20	8.3	-0.2

4	P21	7.6	0.2
4	P22	8.0	0.1
4	P23	7.6	0.5
4	P24	8.2	0.1
5	P1	8.0	0.0
5	P2	7.8	0.1
5	P3	7.9	0.1
5	P4	7.9	0.4
5	P5	7.6	0.1
5	P6	7.9	0.0
5	P7	7.9	0.0
5	P8	7.8	0.0
5	P9	7.6	0.1
5	P10	8.1	-0.1
5	P11	8.0	-0.1
5	P12	7.9	0.0
5	P13	7.8	0.0
5	P14	8.0	0.1
5	P15	7.9	0.0
5	P16	7.9	0.1
5	P17	8.0	0.1
5	P18	7.7	0.1
5	P19	7.5	0.1
5	P20	8.0	-0.1
5	P21	7.9	0.0
5	P22	8.0	0.1
5	P23	7.8	0.0
5	P24	8.1	0.2
6	P1	7.5	0.1
6	P2	7.6	0.2
6	P3	7.5	0.2
6	P4	7.7	0.1
6	P5	7.2	0.1
6	P6	7.7	-0.1
6	P7	7.2	0.1
6	P8	7.4	0.1
6	P9	7.6	0.2
6	P10	7.6	-0.1
6	P11	7.9	-0.1
6	P12	7.6	0.0
6	P13	7.8	-0.1
6	P14	7.3	0.2
6	P15	7.6	0.2
6	P16	8.1	-0.1
6	P17	7.4	0.1
6	P18	7.7	0.1
6	P19	7.6	0.1
6	P20	7.4	0.2
6	P21	7.9	-0.2

6	P22	7.4	0.2
6	P23	7.2	0.1
6	P24	7.9	-0.1
7	P1	7.9	0.0
7	P2	7.2	0.2
7	P3	8.0	0.0
7	P4	7.4	0.2
7	P5	7.8	0.1
7	P6	7.5	0.4
7	P7	7.7	0.4
7	P8	7.7	0.1
7	P9	7.7	0.1
7	P10	7.6	0.4
7	P11	7.7	0.3
7	P12	7.5	0.0
7	P13	8.0	-0.1
7	P14	7.4	0.0
7	P15	7.7	0.0
7	P16	7.6	0.1
7	P17	7.6	-0.1
7	P18	7.4	-0.1
7	P19	7.6	0.0
7	P20	7.4	0.1
7	P21	8.0	0.1
7	P22	7.6	0.1
7	P23	7.5	0.1
7	P24	7.3	0.2
8	P1	7.4	0.5
8	P2	8.5	0.0
8	P3	7.6	0.4
8	P4	8.3	0.1
8	P5	7.6	0.6
8	P6	8.5	0.3
8	P7	7.8	0.5
8	P8	8.7	0.4
8	P9	7.9	0.4
8	P10	8.7	0.4
8	P11	7.8	0.8
8	P12	8.4	0.8
8	P13	7.9	0.8
8	P14	8.9	0.6
8	P15	8.1	0.3
8	P16	8.3	0.5
8	P17	7.9	0.2
8	P18	8.2	0.4
8	P19	7.6	0.5
8	P20	8.8	0.2
8	P21	7.9	0.6
8	P22	8.3	0.7

8	P23	7.7	0.2
8	P24	7.8	0.3

LLCR Thermal:

	mOhm values	Actual	Delta
Board	Position	Initial	Thermal Age
1	P1	7.4	0.0
1	P2	8.0	0.1
1	P3	7.2	0.1
1	P4	8.3	-0.1
1	P5	7.6	0.1
1	P6	8.2	0.0
1	P7	7.7	0.1
1	P8	8.6	-0.2
1	P9	7.6	0.1
1	P10	8.0	0.9
1	P11	7.7	0.1
1	P12	7.8	0.9
1	P13	7.7	0.2
1	P14	8.0	0.6
1	P15	8.1	-0.2
1	P16	8.8	-0.4
1	P17	7.7	0.0
1	P18	8.5	-0.4
1	P19	7.7	0.2
1	P20	8.0	0.8
1	P21	7.8	0.3
1	P22	8.1	0.9
1	P23	7.5	0.4
1	P24	8.0	0.3
2	P1	7.4	0.0
2	P2	8.2	-0.1
2	P3	7.6	0.0
2	P4	8.4	0.0
2	P5	7.5	0.0
2	P6	8.1	0.1
2	P7	7.7	0.1
2	P8	8.0	0.1
2	P9	8.0	-0.2
2	P10	8.5	-0.2
2	P11	7.6	-0.1
2	P12	8.3	0.0
2	P13	7.6	0.1
2	P14	8.5	-0.1
2	P15	7.4	0.1
2	P16	7.9	0.0
2	P17	7.9	-0.1
2	P18	7.9	0.2

2	P19	7.7	-0.1
2	P20	7.9	0.3
2	P21	7.5	0.1
2	P22	8.1	-0.1
2	P23	7.7	0.1
2	P24	7.5	0.2
3	P1	7.9	0.0
3	P2	7.6	0.0
3	P3	7.9	0.0
3	P4	7.8	0.0
3	P5	7.6	0.0
3	P6	8.0	-0.2
3	P7	8.0	-0.1
3	P8	8.1	0.0
3	P9	7.7	0.0
3	P10	8.2	0.1
3	P11	7.8	0.0
3	P12	8.2	0.1
3	P13	7.8	0.3
3	P14	8.3	0.2
3	P15	7.9	0.2
3	P16	8.2	0.1
3	P17	7.9	0.1
3	P18	8.3	-0.2
3	P19	7.6	0.0
3	P20	8.2	0.2
3	P21	7.9	0.0
3	P22	8.0	0.0
3	P23	7.7	0.1
3	P24	8.0	-0.2
4	P1	7.5	0.4
4	P2	7.5	0.3
4	P3	7.6	0.2
4	P4	8.1	0.0
4	P5	7.7	0.6
4	P6	7.9	0.1
4	P7	7.7	0.1
4	P8	7.8	0.2
4	P9	7.7	0.0
4	P10	7.7	0.5
4	P11	7.9	0.3
4	P12	7.9	0.3
4	P13	7.8	0.1
4	P14	7.7	1.1
4	P15	7.5	0.6
4	P16	8.0	0.2
4	P17	7.8	0.2
4	P18	7.6	0.2
4	P19	7.8	0.1

4	P20	7.5	0.5
4	P21	7.7	0.4
4	P22	7.7	0.3
4	P23	7.5	0.5
4	P24	7.9	0.1
5	P1	8.0	0.4
5	P2	7.8	0.2
5	P3	7.5	0.1
5	P4	8.0	0.1
5	P5	8.1	0.0
5	P6	8.1	0.5
5	P7	7.7	0.1
5	P8	8.3	0.3
5	P9	7.8	0.4
5	P10	8.1	0.3
5	P11	7.8	0.1
5	P12	8.5	0.1
5	P13	8.0	0.1
5	P14	8.6	0.1
5	P15	7.9	0.1
5	P16	8.4	0.2
5	P17	7.9	0.1
5	P18	8.3	0.0
5	P19	8.1	-0.2
5	P20	8.3	0.3
5	P21	7.7	0.1
5	P22	8.6	-0.5
5	P23	7.7	0.1
5	P24	8.4	0.2
6	P1	7.4	-0.1
6	P2	7.3	-0.2
6	P3	7.2	-0.1
6	P4	7.3	-0.1
6	P5	7.3	0.0
6	P6	7.7	-0.1
6	P7	7.5	0.0
6	P8	7.5	-0.1
6	P9	7.4	-0.1
6	P10	7.8	-0.1
6	P11	7.4	-0.1
6	P12	7.6	-0.1
6	P13	7.4	0.0
6	P14	7.6	-0.1
6	P15	7.4	-0.1
6	P16	7.3	-0.1
6	P17	7.6	0.0
6	P18	7.3	0.0
6	P19	7.4	0.0
6	P20	7.5	-0.1

6	P21	7.6	0.0
6	P22	7.4	0.0
6	P23	6.9	0.0
6	P24	7.8	-0.1
7	P1	7.7	-0.1
7	P2	7.4	-0.1
7	P3	7.4	0.0
7	P4	7.5	0.0
7	P5	7.4	0.0
7	P6	7.3	0.2
7	P7	7.5	0.0
7	P8	7.5	0.0
7	P9	7.6	-0.1
7	P10	7.4	0.0
7	P11	7.6	-0.1
7	P12	7.3	-0.1
7	P13	7.5	0.0
7	P14	7.5	-0.1
7	P15	7.7	-0.1
7	P16	7.4	-0.1
7	P17	7.8	-0.2
7	P18	7.4	0.0
7	P19	7.7	-0.1
7	P20	7.5	-0.1
7	P21	7.6	0.0
7	P22	7.8	-0.1
7	P23	7.7	0.0
7	P24	7.7	0.0
8	P1	7.2	0.1
8	P2	7.2	0.0
8	P3	7.4	0.0
8	P4	7.2	0.0
8	P5	7.5	0.0
8	P6	7.3	0.0
8	P7	7.6	-0.1
8	P8	7.3	0.0
8	P9	7.1	0.1
8	P10	7.3	0.1
8	P11	7.2	0.2
8	P12	7.1	0.0
8	P13	7.6	0.0
8	P14	7.2	0.0
8	P15	7.6	0.0
8	P16	7.4	0.0
8	P17	7.6	0.1
8	P18	7.2	0.2
8	P19	7.4	0.0
8	P20	7.3	0.1
8	P21	7.8	0.2

8	P22	7.3	0.1
8	P23	7.4	0.1
8	P24	7.1	0.2

LLCR Durability:

	mOhm values	Actual	Delta	Delta	Delta
Board	Position	Initial	100 Cycles	Thermal	Humidity
1	P1	8.1	0.4	-0.3	-0.2
1	P2	7.4	-0.1	-0.3	-0.2
1	P3	7.7	-0.1	-0.1	0.0
1	P4	7.7	-0.1	-0.3	-0.2
1	P5	7.9	0.0	0.0	0.1
1	P6	7.8	-0.1	0.0	-0.2
1	P7	7.9	0.0	-0.2	-0.1
1	P8	8.0	-0.2	-0.1	-0.1
1	P9	7.8	0.0	-0.2	-0.2
1	P10	7.9	0.0	-0.2	-0.2
1	P11	8.1	0.0	-0.2	-0.2
1	P12	7.6	0.0	-0.2	-0.1
1	P13	8.0	0.0	-0.2	-0.2
1	P14	7.6	0.0	0.0	0.0
1	P15	7.7	0.1	-0.1	-0.1
1	P16	7.5	0.0	-0.2	-0.1
1	P17	7.8	0.0	-0.2	-0.2
1	P18	7.6	0.1	-0.3	-0.3
1	P19	7.7	0.1	-0.2	-0.2
1	P20	7.6	0.1	-0.1	0.0
1	P21	7.9	0.1	0.0	0.1
1	P22	7.9	0.0	0.0	0.1
1	P23	7.8	0.2	0.1	0.8
1	P24	7.7	-0.1	-0.2	-0.1
2	P1	7.5	0.1	-0.1	0.0
2	P2	7.3	0.3	0.2	0.0
2	P3	7.1	0.2	0.1	0.4
2	P4	7.5	-0.3	-0.5	-0.4
2	P5	7.6	0.0	-0.3	-0.2
2	P6	7.5	-0.1	-0.1	-0.2
2	P7	7.6	-0.1	-0.1	-0.1
2	P8	7.6	0.0	-0.2	-0.2
2	P9	7.3	0.0	-0.1	-0.1
2	P10	7.4	-0.1	-0.3	-0.2
2	P11	7.5	0.0	-0.3	-0.3
2	P12	7.4	0.0	-0.2	-0.1
2	P13	7.5	-0.1	-0.2	-0.1
2	P14	7.7	-0.1	-0.3	-0.3
2	P15	7.5	-0.1	-0.3	-0.3
2	P16	8.1	-0.4	-0.5	-0.5
2	P17	7.4	0.0	-0.2	-0.2

2	P18	7.8	-0.1	-0.3	-0.2
2	P19	7.4	0.1	-0.2	-0.2
2	P20	7.6	0.1	0.1	0.1
2	P21	7.7	-0.1	-0.2	-0.1
2	P22	7.8	0.0	0.0	0.0
2	P23	7.5	0.0	-0.2	-0.1
2	P24	7.5	0.0	0.4	-0.1
3	P1	7.9	-0.1	-0.4	-0.4
3	P2	8.0	0.0	-0.3	-0.3
3	P3	7.8	0.0	-0.3	-0.2
3	P4	8.1	0.1	-0.2	-0.1
3	P5	7.8	0.0	-0.2	-0.1
3	P6	8.0	0.0	-0.2	-0.1
3	P7	7.9	0.0	-0.3	-0.2
3	P8	7.8	0.0	-0.2	-0.2
3	P9	7.9	0.0	-0.5	-0.5
3	P10	7.8	0.2	-0.2	-0.2
3	P11	8.1	-0.1	-0.4	-0.3
3	P12	7.6	0.2	-0.1	-0.1
3	P13	7.9	0.0	-0.2	-0.2
3	P14	7.6	0.1	0.0	0.0
3	P15	8.1	-0.1	-0.2	-0.2
3	P16	7.8	0.1	-0.1	0.0
3	P17	8.0	-0.2	-0.4	-0.4
3	P18	7.7	0.2	0.0	0.0
3	P19	7.9	-0.3	-0.4	-0.4
3	P20	7.8	0.1	-0.1	-0.1
3	P21	8.0	0.0	0.0	0.0
3	P22	7.5	0.1	-0.1	0.0
3	P23	7.7	-0.1	-0.2	-0.2
3	P24	7.8	0.1	-0.1	-0.1
4	P1	7.8	-0.1	-0.3	-0.3
4	P2	8.4	-0.2	-0.5	-0.4
4	P3	7.5	0.1	-0.2	-0.1
4	P4	8.7	-0.3	-0.3	-0.2
4	P5	8.2	-0.2	-0.4	-0.2
4	P6	8.0	0.1	-0.1	0.0
4	P7	7.8	0.1	-0.3	-0.1
4	P8	8.0	0.3	0.0	0.2
4	P9	8.2	-0.1	-0.3	-0.3
4	P10	7.9	0.0	-0.3	-0.3
4	P11	8.0	0.1	-0.3	-0.2
4	P12	8.7	0.2	-0.2	-0.2
4	P13	8.2	-0.3	-0.8	-0.8
4	P14	8.2	-0.1	0.0	0.1
4	P15	7.4	0.1	-0.1	-0.1
4	P16	8.2	0.2	-0.2	-0.4
4	P17	8.0	-0.1	-0.3	-0.3
4	P18	9.0	-0.4	-0.4	-0.4

4	P19	8.0	-0.1	-0.2	-0.2
4	P20	8.9	-0.2	-0.5	-0.4
4	P21	8.3	-0.3	-0.5	-0.5
4	P22	8.8	-0.7	-0.7	-0.3
4	P23	8.0	-0.4	-0.5	-0.5
4	P24	8.4	-0.2	-0.4	-0.3
5	P1	7.8	0.2	0.0	0.0
5	P2	7.2	0.1	0.0	0.0
5	P3	7.8	-0.1	-0.1	-0.1
5	P4	7.9	-0.5	-0.5	-0.4
5	P5	7.9	-0.3	-0.4	-0.3
5	P6	7.7	-0.2	-0.3	-0.3
5	P7	7.9	-0.3	-0.3	-0.2
5	P8	7.5	0.1	0.0	0.0
5	P9	7.4	0.1	0.0	0.1
5	P10	7.8	-0.1	-0.3	-0.3
5	P11	7.8	0.0	0.0	0.0
5	P12	7.9	-0.2	-0.4	-0.4
5	P13	7.7	0.0	0.2	0.1
5	P14	8.0	-0.4	-0.5	-0.5
5	P15	7.5	0.1	0.2	0.2
5	P16	7.9	-0.3	-0.4	-0.4
5	P17	8.1	-0.1	-0.1	-0.1
5	P18	7.7	-0.1	-0.3	-0.4
5	P19	7.8	0.0	-0.3	-0.3
5	P20	7.7	-0.1	-0.3	-0.3
5	P21	7.6	0.3	0.1	0.2
5	P22	7.9	-0.1	-0.1	-0.1
5	P23	8.3	0.1	0.0	0.1
5	P24	7.6	0.2	-0.2	0.0
6	P1	7.8	0.0	-0.1	-0.2
6	P2	7.3	0.1	0.1	0.0
6	P3	8.2	-0.1	-0.1	-0.2
6	P4	7.5	-0.1	0.0	0.0
6	P5	8.0	-0.1	0.0	0.1
6	P6	8.3	-0.7	-0.6	-0.6
6	P7	8.4	-0.5	-0.5	-0.6
6	P8	7.5	0.1	-0.1	0.0
6	P9	8.6	-0.2	-0.3	-0.3
6	P10	7.9	0.1	-0.1	-0.1
6	P11	8.0	0.0	0.2	0.2
6	P12	7.6	0.0	-0.1	-0.1
6	P13	8.3	-0.2	-0.1	-0.1
6	P14	7.8	-0.1	-0.1	-0.2
6	P15	8.2	-0.3	-0.2	-0.2
6	P16	7.5	-0.1	0.0	-0.1
6	P17	8.2	0.0	0.0	-0.2
6	P18	7.7	-0.3	-0.3	-0.4
6	P19	8.0	-0.3	-0.3	-0.2

6	P20	7.7	-0.2	-0.1	-0.2
6	P21	8.4	-0.2	-0.1	-0.1
6	P22	7.5	-0.2	-0.2	-0.2
6	P23	8.0	0.5	0.2	0.3
6	P24	7.6	-0.1	-0.3	-0.2
7	P1	8.3	0.3	0.1	-0.1
7	P2	7.6	-0.1	0.0	-0.1
7	P3	8.1	-0.1	-0.1	-0.3
7	P4	7.6	-0.1	0.0	0.0
7	P5	8.0	0.3	0.1	0.1
7	P6	8.1	-0.1	-0.5	-0.4
7	P7	7.7	0.1	0.2	0.2
7	P8	7.6	0.0	-0.2	-0.3
7	P9	8.3	-0.2	-0.1	-0.2
7	P10	7.8	0.1	0.0	-0.1
7	P11	8.4	-0.2	0.0	0.0
7	P12	7.7	0.1	0.3	0.2
7	P13	8.1	0.1	0.4	0.4
7	P14	8.0	0.0	-0.1	-0.1
7	P15	7.8	0.0	0.1	0.0
7	P16	7.7	0.1	0.1	0.0
7	P17	7.6	0.0	0.2	0.0
7	P18	7.4	0.1	0.0	-0.1
7	P19	7.6	0.1	0.2	0.2
7	P20	7.7	0.0	0.1	0.0
7	P21	8.4	-0.1	-0.1	-0.2
7	P22	7.7	-0.1	0.0	0.1
7	P23	8.0	0.4	0.3	0.4
7	P24	7.4	0.0	0.0	0.1
8	P1	7.5	-0.2	-0.3	-0.3
8	P2	7.6	-0.3	-0.4	-0.4
8	P3	7.5	-0.1	-0.2	-0.1
8	P4	7.7	-0.2	-0.2	-0.2
8	P5	7.7	-0.3	-0.2	-0.1
8	P6	7.7	0.0	-0.1	-0.1
8	P7	7.5	-0.1	-0.2	-0.1
8	P8	7.7	-0.2	-0.2	-0.2
8	P9	7.4	0.0	-0.2	-0.2
8	P10	7.9	-0.1	-0.2	-0.2
8	P11	7.6	-0.2	-0.3	-0.3
8	P12	8.2	-0.4	-0.5	-0.5
8	P13	7.6	-0.1	-0.2	-0.2
8	P14	8.2	-0.1	-0.3	-0.3
8	P15	7.7	0.1	-0.1	-0.1
8	P16	7.7	-0.2	-0.3	-0.3
8	P17	8.1	-0.2	-0.4	-0.4
8	P18	7.6	-0.3	-0.4	-0.3
8	P19	7.6	-0.1	-0.2	-0.2
8	P20	8.3	-0.1	-0.3	-0.3

8	P21	8.2	-0.6	-0.8	-0.7
8	P22	8.0	0.0	-0.2	-0.2
8	P23	7.8	-0.1	-0.3	-0.1
8	P24	7.4	-0.1	-0.2	-0.1

LLCR Shock / Vibration:

	mOhm values	Actual	Delta
Board	Position	Initial	Shock / Vibe
1	P1	7.6	-0.1
1	P2	7.4	-0.1
1	P3	7.7	-0.2
1	P4	7.5	-0.2
1	P5	7.9	4.1
1	P6	7.4	-0.2
1	P7	7.8	-0.2
1	P8	7.8	-0.1
1	P9	7.9	0.0
1	P10	8.1	-0.1
1	P11	7.6	0.0
1	P12	7.7	-0.2
1	P13	7.5	-0.1
1	P14	7.7	-0.2
1	P15	7.9	-0.1
1	P16	7.7	-0.1
1	P17	7.8	-0.1
1	P18	7.7	0.0
1	P19	7.9	0.0
1	P20	7.6	0.0
1	P21	8.0	-0.2
1	P22	8.1	-0.5
1	P23	8.2	6.0
1	P24	7.5	-0.1
2	P1	7.8	-0.1
2	P2	7.6	-0.2
2	P3	7.5	-0.1
2	P4	7.7	-0.2
2	P5	7.7	2.0
2	P6	7.8	-0.2
2	P7	7.9	-0.1
2	P8	7.8	-0.1
2	P9	7.9	-0.1
2	P10	8.0	-0.1
2	P11	8.1	-0.2
2	P12	7.8	-0.2
2	P13	7.7	-0.2
2	P14	7.2	-0.1
2	P15	7.3	-0.1
2	P16	7.4	-0.2

2	P17	7.1	-0.1
2	P18	7.1	-0.1
2	P19	7.5	-0.1
2	P20	7.4	-0.2
2	P21	7.7	-0.3
2	P22	7.8	-0.4
2	P23	7.7	0.9
2	P24	7.9	-0.2
3	P1	7.7	0.0
3	P2	7.3	-0.2
3	P3	8.4	-0.3
3	P4	8.0	-0.3
3	P5	7.9	-0.4
3	P6	8.1	-0.3
3	P7	7.9	0.0
3	P8	7.5	-0.2
3	P9	8.6	-0.3
3	P10	7.7	-0.1
3	P11	8.2	0.0
3	P12	7.9	-0.1
3	P13	8.6	-0.3
3	P14	7.6	0.0
3	P15	7.9	0.6
3	P16	7.8	-0.2
3	P17	8.8	-0.3
3	P18	7.4	0.0
3	P19	7.9	0.0
3	P20	7.9	-0.1
3	P21	7.9	-0.1
3	P22	7.4	-0.2
3	P23	7.6	-0.4
3	P24	7.4	-0.3
4	P1	7.6	-0.3
4	P2	7.4	-0.3
4	P3	7.4	-0.3
4	P4	8.1	-0.3
4	P5	7.9	0.8
4	P6	8.0	-0.5
4	P7	7.9	-0.2
4	P8	7.4	-0.2
4	P9	8.2	-0.4
4	P10	7.9	-0.2
4	P11	8.5	-0.4
4	P12	8.2	-0.3
4	P13	8.2	-0.3
4	P14	8.6	-0.6
4	P15	8.0	-0.2
4	P16	7.7	-0.1
4	P17	7.9	-0.1

4	P18	8.0	-0.1
4	P19	8.0	-0.2
4	P20	8.5	-0.5
4	P21	7.9	-0.4
4	P22	7.6	-0.4
4	P23	8.1	0.3
4	P24	7.6	-0.2
5	P1	7.1	-0.1
5	P2	6.9	-0.1
5	P3	7.1	0.0
5	P4	7.3	0.0
5	P5	7.2	0.6
5	P6	7.3	-0.3
5	P7	7.2	0.0
5	P8	7.2	-0.1
5	P9	7.4	-0.1
5	P10	7.3	0.0
5	P11	7.5	-0.1
5	P12	7.1	-0.1
5	P13	7.1	-0.1
5	P14	7.2	-0.1
5	P15	7.3	-0.2
5	P16	7.2	-0.1
5	P17	7.2	0.0
5	P18	7.2	0.0
5	P19	7.4	-0.1
5	P20	7.3	0.0
5	P21	7.4	-0.1
5	P22	7.3	-0.1
5	P23	7.3	1.3
5	P24	7.3	-0.1
6	P1	8.0	-0.5
6	P2	7.9	-0.8
6	P3	7.2	-0.2
6	P4	7.5	-0.1
6	P5	7.5	-0.2
6	P6	8.0	-0.6
6	P7	7.5	-0.3
6	P8	8.0	-0.2
6	P9	7.5	-0.1
6	P10	8.2	-0.2
6	P11	7.5	-0.1
6	P12	8.4	0.0
6	P13	8.3	-0.4
6	P14	7.8	-0.1
6	P15	7.5	-0.1
6	P16	8.0	-0.1
6	P17	7.6	0.0
6	P18	8.0	-0.1

6	P19	7.6	0.0
6	P20	7.7	-0.2
6	P21	8.0	-0.3
6	P22	8.3	-0.4
6	P23	7.4	0.7
6	P24	8.1	-0.2
7	P1	7.8	-0.1
7	P2	7.6	0.0
7	P3	7.5	0.0
7	P4	7.6	0.0
7	P5	7.9	-0.2
7	P6	7.8	-0.1
7	P7	8.0	-0.1
7	P8	7.8	-0.1
7	P9	7.9	0.0
7	P10	8.0	0.0
7	P11	7.8	0.0
7	P12	7.7	0.0
7	P13	8.0	0.0
7	P14	8.0	0.0
7	P15	7.9	-0.1
7	P16	8.0	0.0
7	P17	8.0	-0.1
7	P18	7.7	0.0
7	P19	7.9	-0.1
7	P20	7.9	-0.1
7	P21	8.3	-0.1
7	P22	8.2	-0.2
7	P23	7.9	-0.1
7	P24	7.6	-0.1
8	P1	8.4	0.0
8	P2	7.8	-0.1
8	P3	8.0	-0.1
8	P4	7.8	-0.2
8	P5	8.1	2.9
8	P6	7.9	-0.4
8	P7	7.7	-0.3
8	P8	7.7	0.0
8	P9	8.2	0.0
8	P10	7.7	0.0
8	P11	8.4	0.0
8	P12	7.5	0.0
8	P13	8.6	-0.2
8	P14	7.8	-0.1
8	P15	8.4	-0.2
8	P16	7.7	0.1
8	P17	8.1	-0.1
8	P18	7.6	-0.1
8	P19	8.1	-0.1

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Part description: SQW/TMM	

8	P20	7.4	-0.2
8	P21	8.6	-0.5
8	P22	7.6	-0.1
8	P23	7.2	2.8
8	P24	7.5	-0.2

EQUIPMENT AND CALIBRATION SCHEDULES**Equipment #:** HZ-TCT-01**Description:** Normal force analyzer**Manufacturer:** Mecmesin Multitester**Model:** Mecmesin Multitester 2.5-i**Serial #:** 08-1049-04**Accuracy:** Last Cal: 4/27/2011, Next Cal: 4/26/2012**Equipment #:** HZ-OV-01**Description:** Oven**Manufacturer:** Huida**Model:** CS101-1E**Serial #:** CS101-1E-B**Accuracy:** Last Cal: 12/14/2010, Next Cal: 12/13/2011**Equipment #:** HZ-THC-01**Description:** Humidity transmitter**Manufacturer:** Thermtron**Model:** HMM30C**Serial #:** D0240037**Accuracy:** Last Cal: 3/2/2011, Next Cal: 3/1/2012**Equipment #:** HZ-TSC-01**Description:** Thermal Shock transmitter**Manufacturer:** Keithley**Model:** 10-VT14994**Serial #:** VTS-3-6-6-SC/AC**Accuracy:** Last Cal: 2010-11-1, Next Cal: 2011-11-1**Equipment #:** HZ-OGP-01**Description:** Video measurement system**Manufacturer:** OGP**Model:** SMARTSCOPE FLASH 200**Serial #:** SVW2003632**Accuracy:** Last Cal: 6/9/2011, Next Cal: 6/8/2012**Equipment #:** HZ-MO-01**Description:** Micro-ohmmeter**Manufacturer:** Keithley**Model:** 2700**Serial #:** 1199807**Accuracy:** Last Cal: 4/27/2011, Next Cal: 4/26/2012

EQUIPMENT AND CALIBRATION SCHEDULES Continued**Equipment #:** HZ-PS-01**Description:** Power Supply**Manufacturer:** Agilent**Model:** 6031A**Serial #:** MY41000982**Accuracy:** Last Cal: 4/27/2011, Next Cal: 4/26/2012**Equipment #:** HZ-HPM-01**Description:** NA9636H**Manufacturer:** Ainuo**Model:** 6031A**Serial #:** 089601091**Accuracy:** Last Cal: 3/8/2011, Next Cal: 3/7/2012**Equipment #:** SVC-01**Description:** Shock & Vibration Table**Manufacturer:** Data Physics**Model:** LE-DSA-10-20K**Serial #:** 10037**Accuracy:** See Manual

... Last Cal: 11/31/2010, Next Cal: 11/31/2011

Equipment #: ACLM-01**Description:** Accelerometer**Manufacturer:** PCB Piezotronics**Model:** 352C03**Serial #:** 115819**Accuracy:** See Manual

... Last Cal: 07/09/2011, Next Cal: 07/09/2012

Equipment #: ED-03**Description:** Event Detector**Manufacturer:** Analysis Tech**Model:** 32EHD**Serial #:** 1100604**Accuracy:** See Manual

... Last Cal: 06/04/2011, Next Cal: 06/04/2012